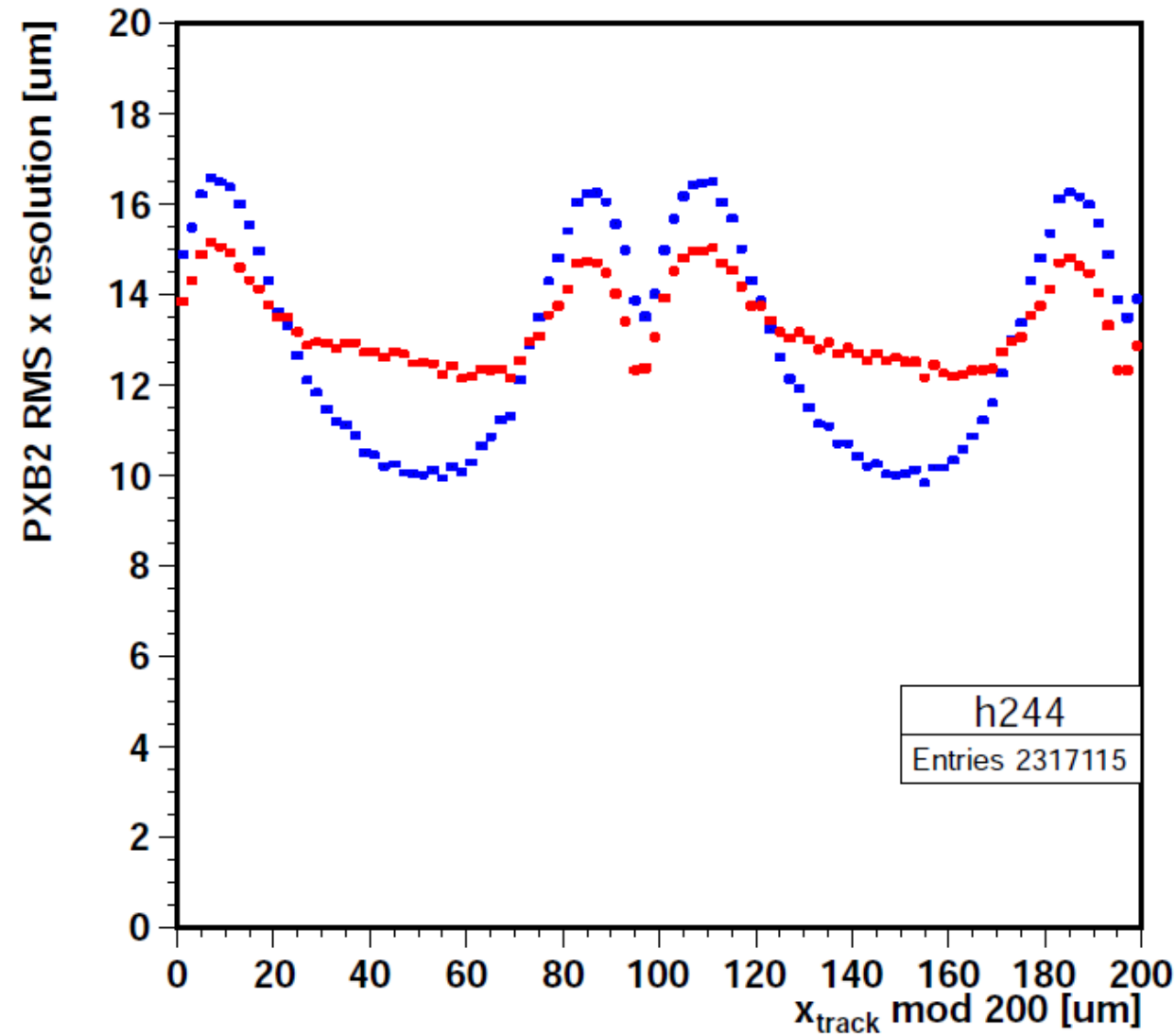


in-pixel resolution studies

Daniel Pitzl, DESY

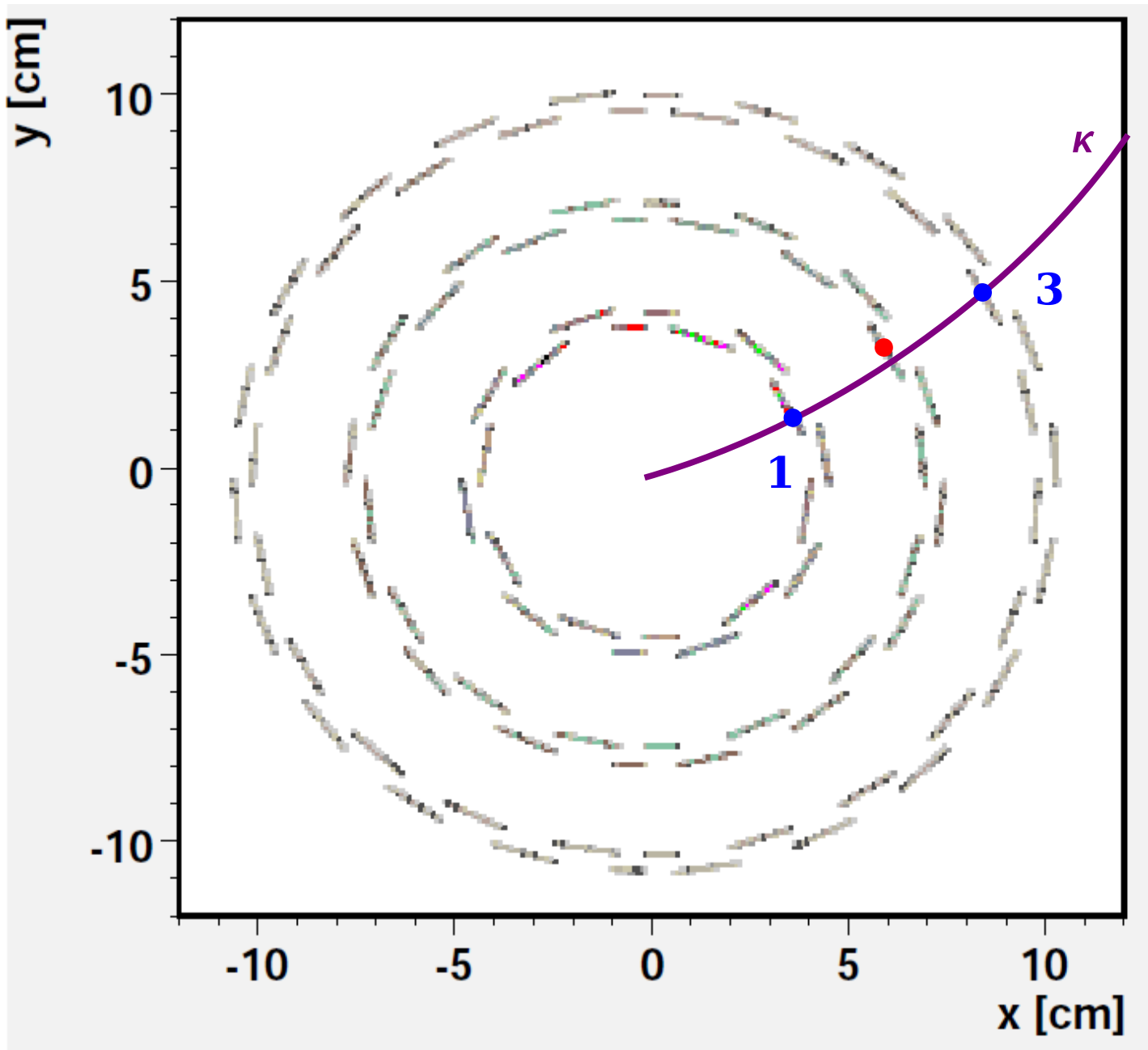
CMS Pixel DPG, 30.6.2011

updated 3.1.2012



- Pixel resolution from triplets
- Charge sharing
- Profiles within a pixel

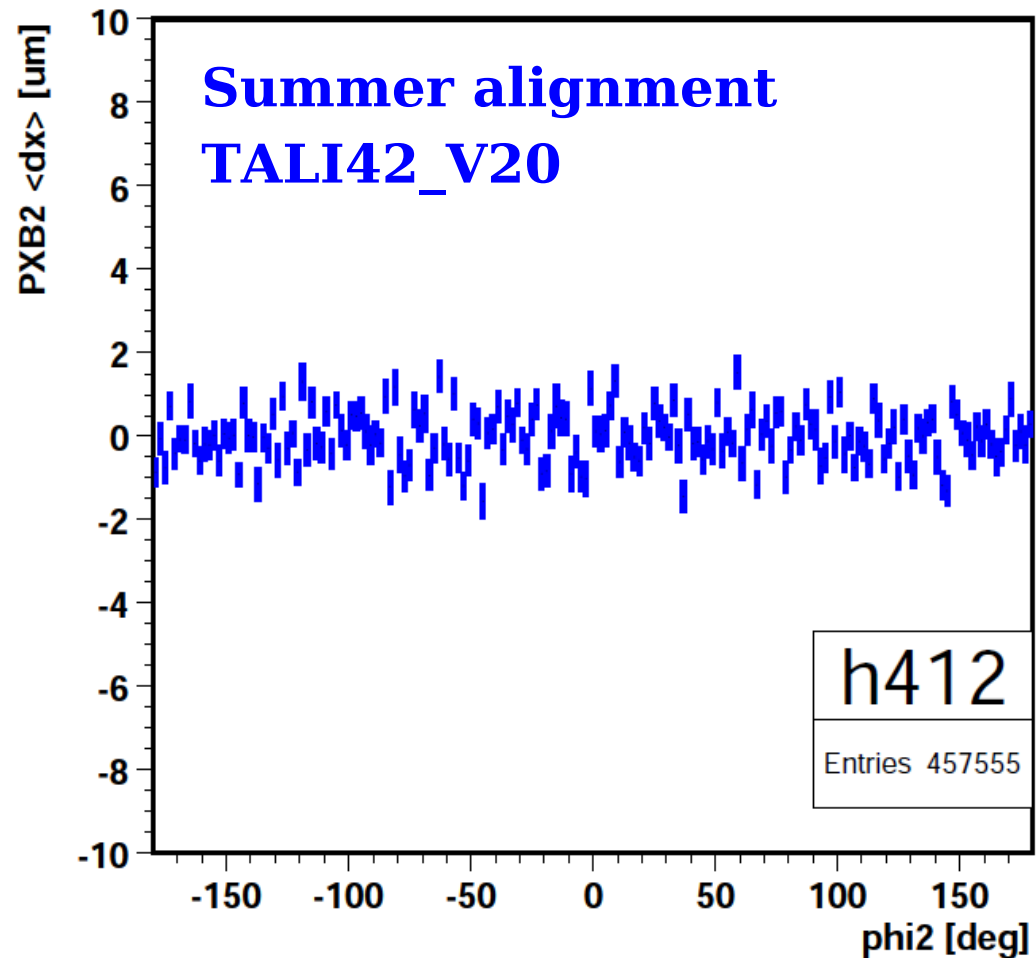
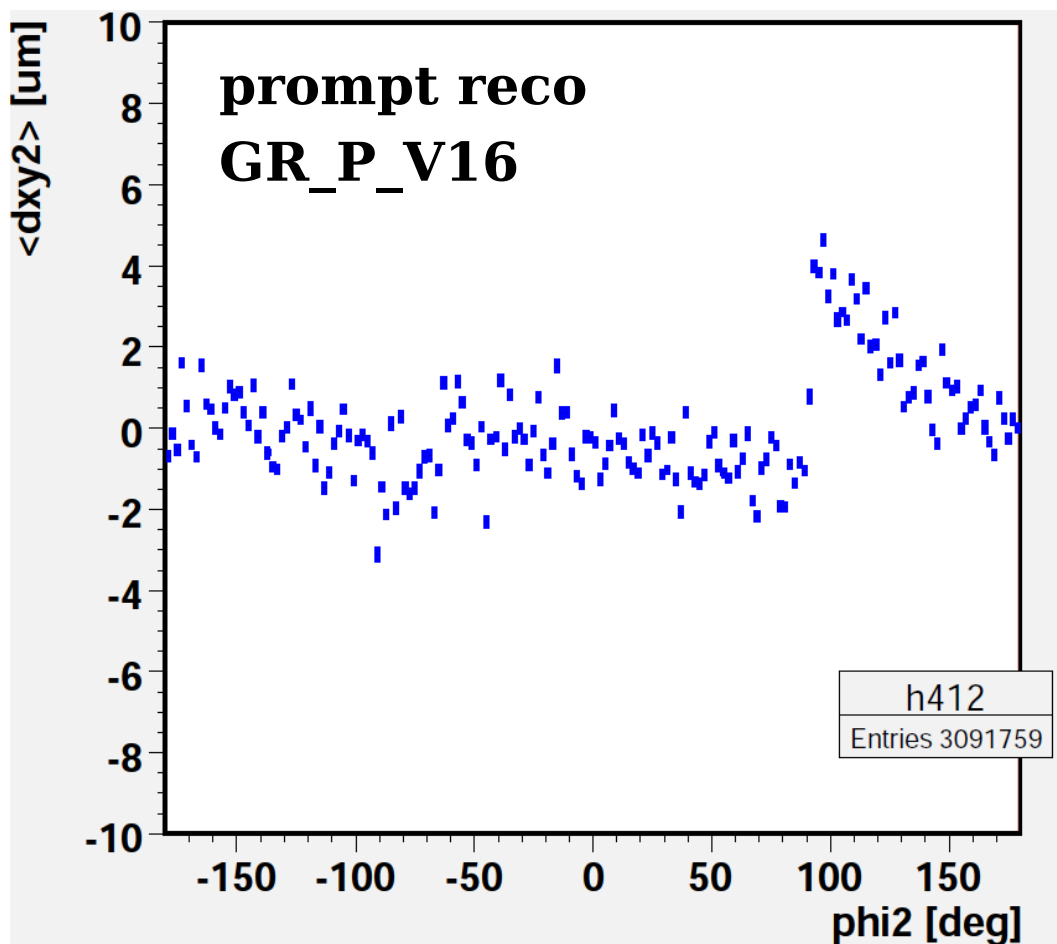
Pixel triplets



- Select tracks with hits in 3 pixel layers.
- Redefine track:
 - curvature κ from full tracker,
 - position and angles from hits 1 and 3.
 - analytic code from J. Gassner 1996 (ETH Zürich, H1).
- Interpolate to middle layer:
 - residual between track and hit.

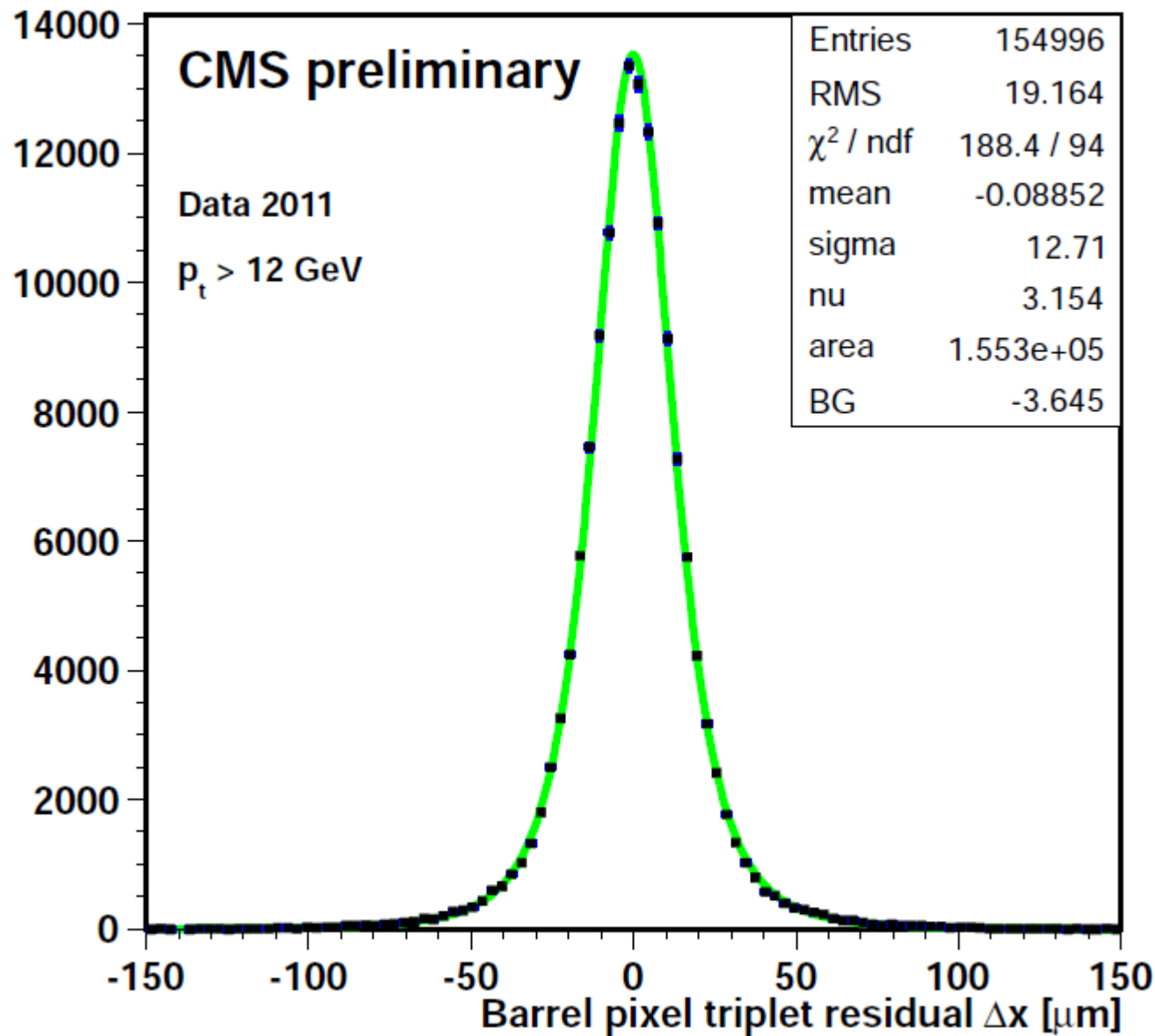
mean residual: alignment check

PXB2, Spring 2011 data



$p_t > 4 \text{ GeV}$

Barrel pixel triplet $r\phi$ residuals at high p_t



- Data Mar 2011
- Width of the residual distribution at high p_t :

$$\sigma_r^2 = \sigma_2^2 + (\sigma_1/2)^2 + (\sigma_3/2)^2$$

- All σ equal:

$$\sigma_r = \sqrt{3/2} \sigma_i$$

- Result:

- $\sigma_r = 12.7 \mu\text{m}$,
- $\sigma_i = 10.4 \mu\text{m}$.
- with $100 \mu\text{m}$ pixel size!

triplet resolution function

Propagation of the intrinsic resolution at high p_t :

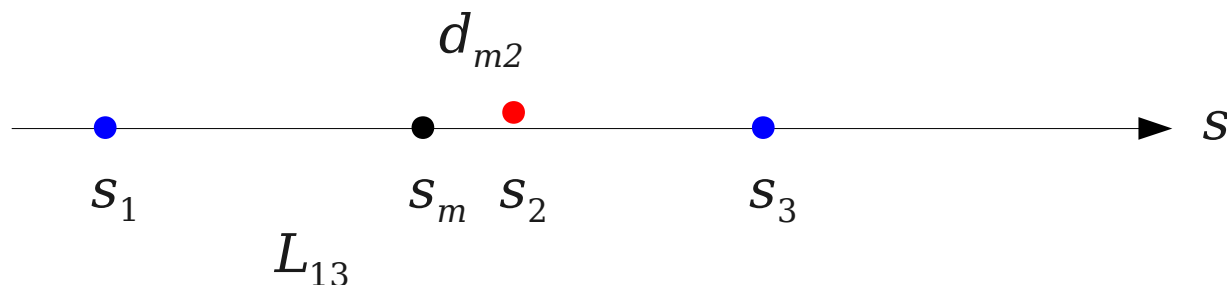
$$\sigma_r^2 = \sigma_2^2 + \frac{\sigma_1^2}{4} + \frac{\sigma_3^2}{4} + \frac{d_{m2}^2}{L_{13}^2} (\sigma_1^2 + \sigma_3^2)$$

$L_{13} = s_3 - s_1$ length of base line

$d_{m2} = s_2 - s_m$ distance of point 2 from mid point

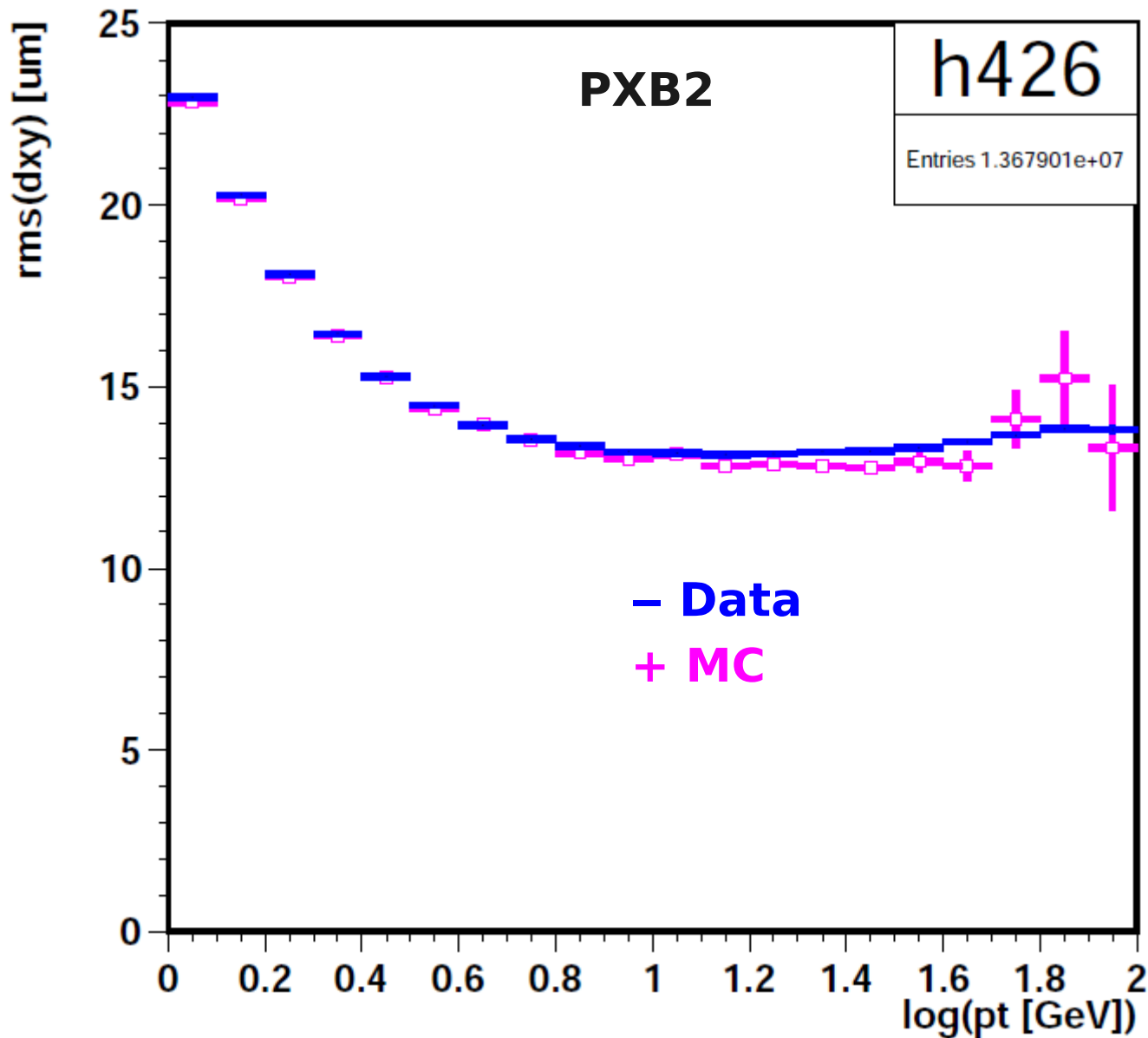
$s_m = (s_1 + s_3)/2$ mid point

s radial coordinate (arc length)



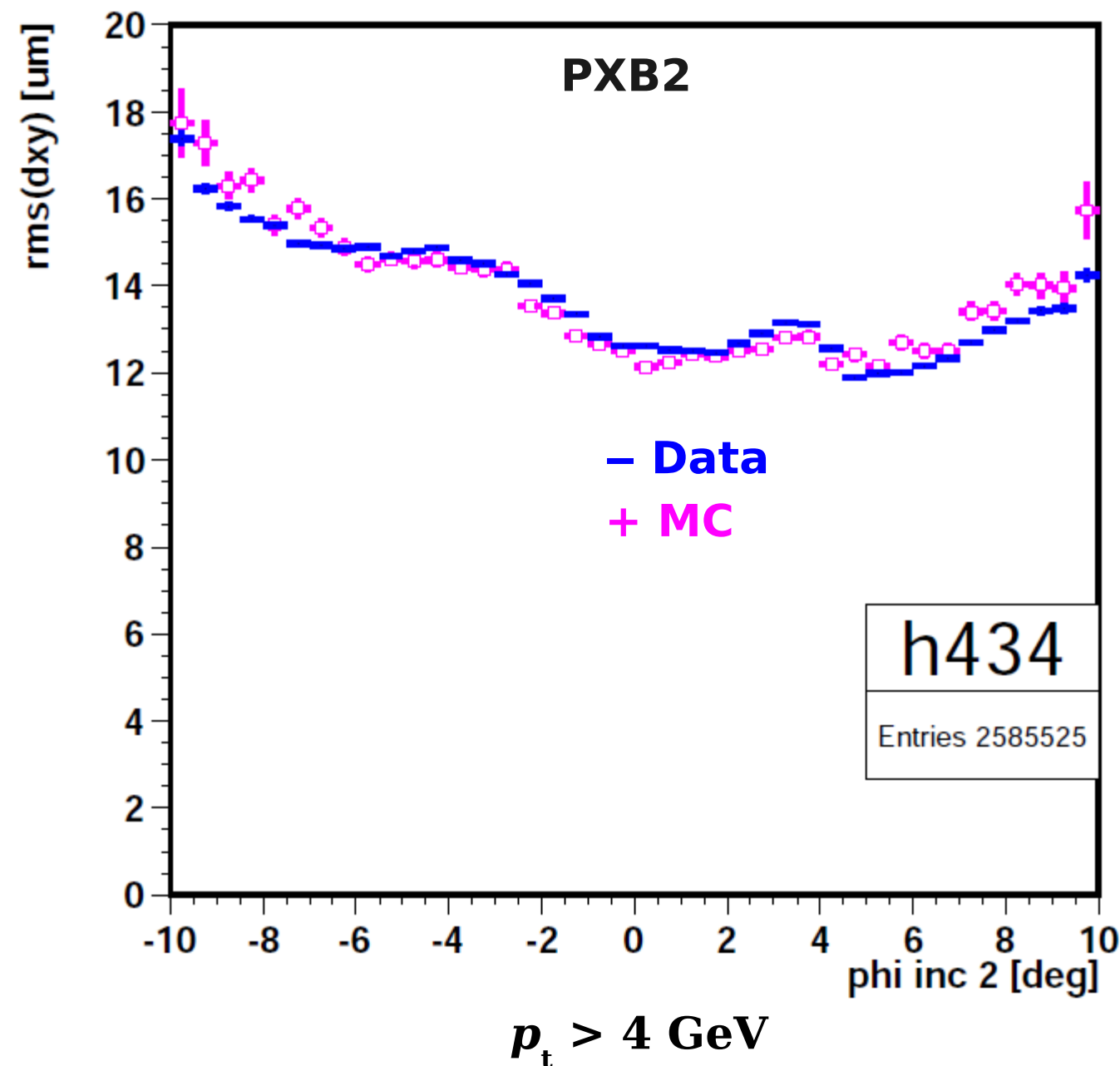
like for a straight line developed around its center,
where offset and slope are uncorrelated.

p_t dependence of $r\phi$ resolution



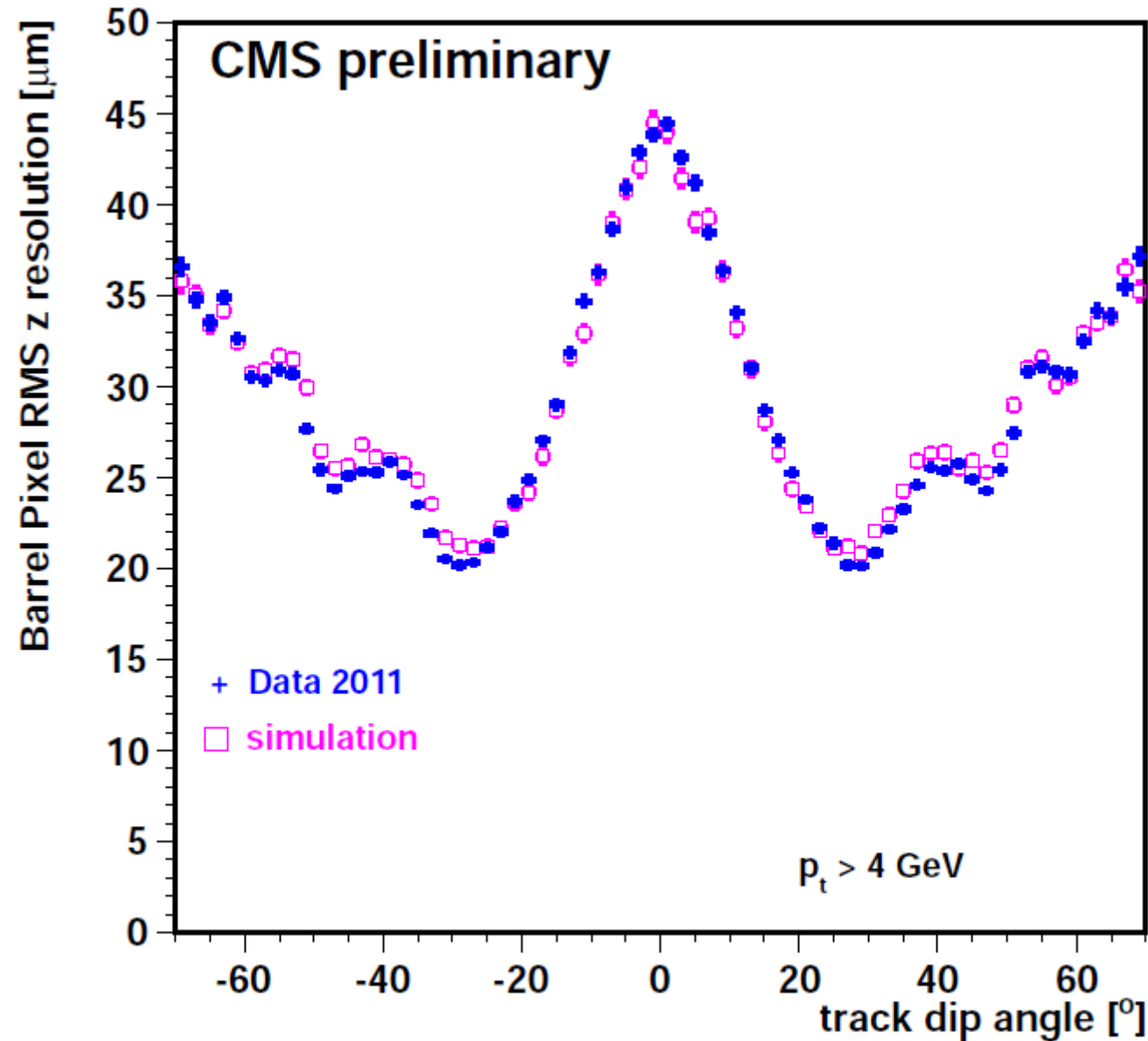
- Width of the residual distribution is affected by multiple scattering in layers 1 and 2:
 - Need $p_t > 4$ GeV to observe intrinsic pixel resolution.
- Very well described by simulation.

incident angle dependence of $r\phi$ resolution

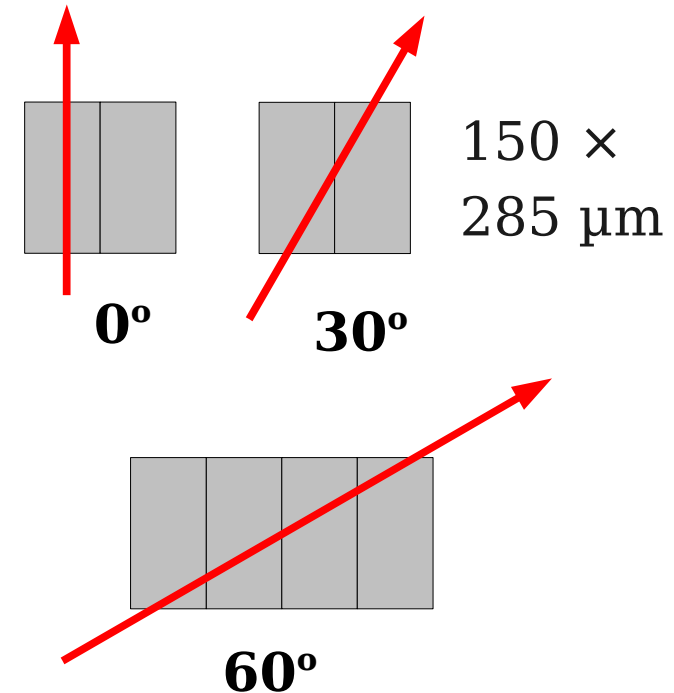


- Pixel barrel layer 2 has 30 (full) modules:
 - each covers $\pm 6^\circ$ in azimuth.
 - larger angles due to curvature (lower p_t).
- Optimal $r\phi$ resolution reached for incidence between -1° and $+7^\circ$.
- Quite well described by simulation.

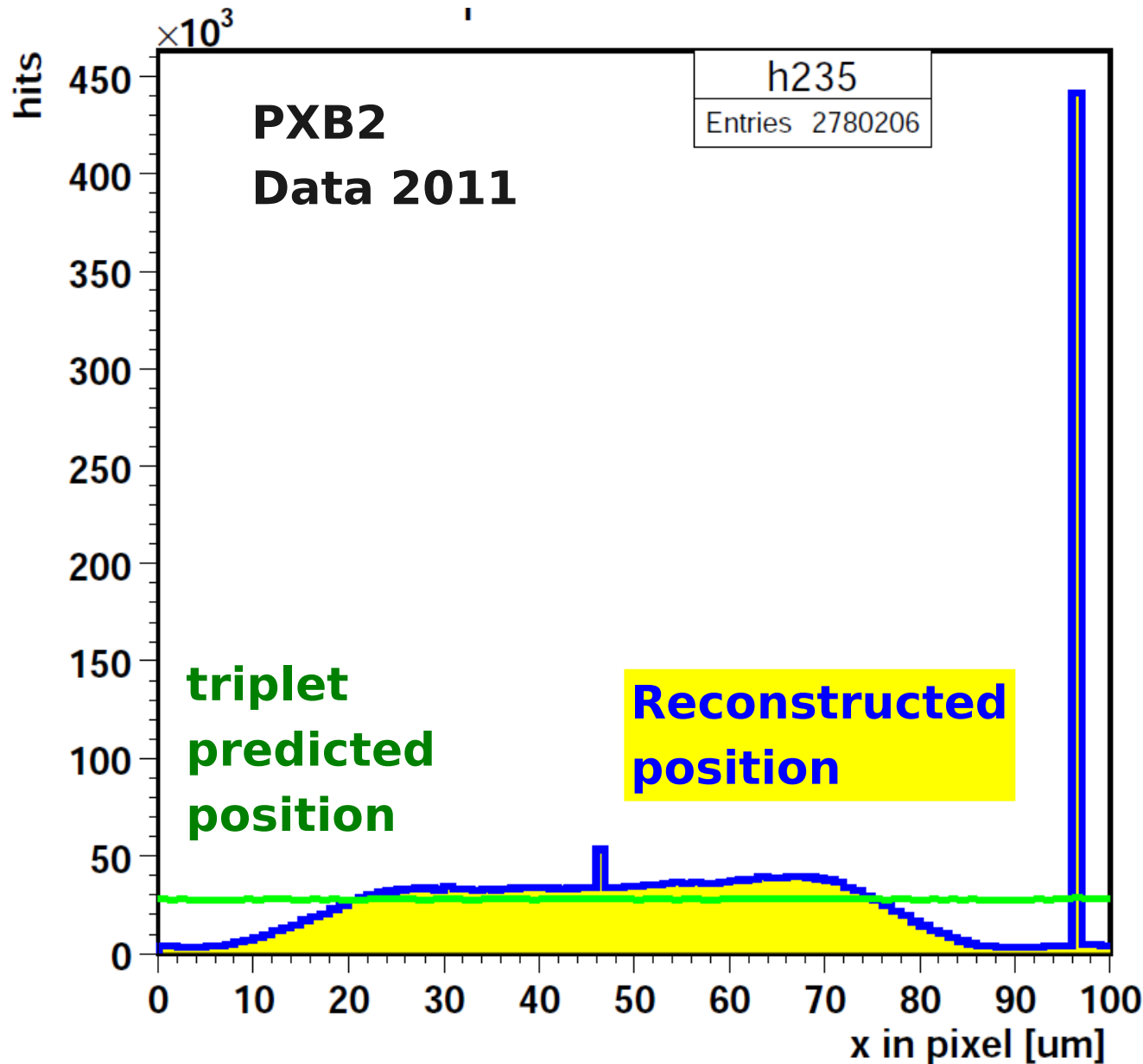
dip angle dependence of z resolution



- dip angle:
 - $\lambda = \pi/2 - \theta$.
- optimal resolution at $\lambda = \pm 30^\circ$:
 - sharing between neighboring pixels

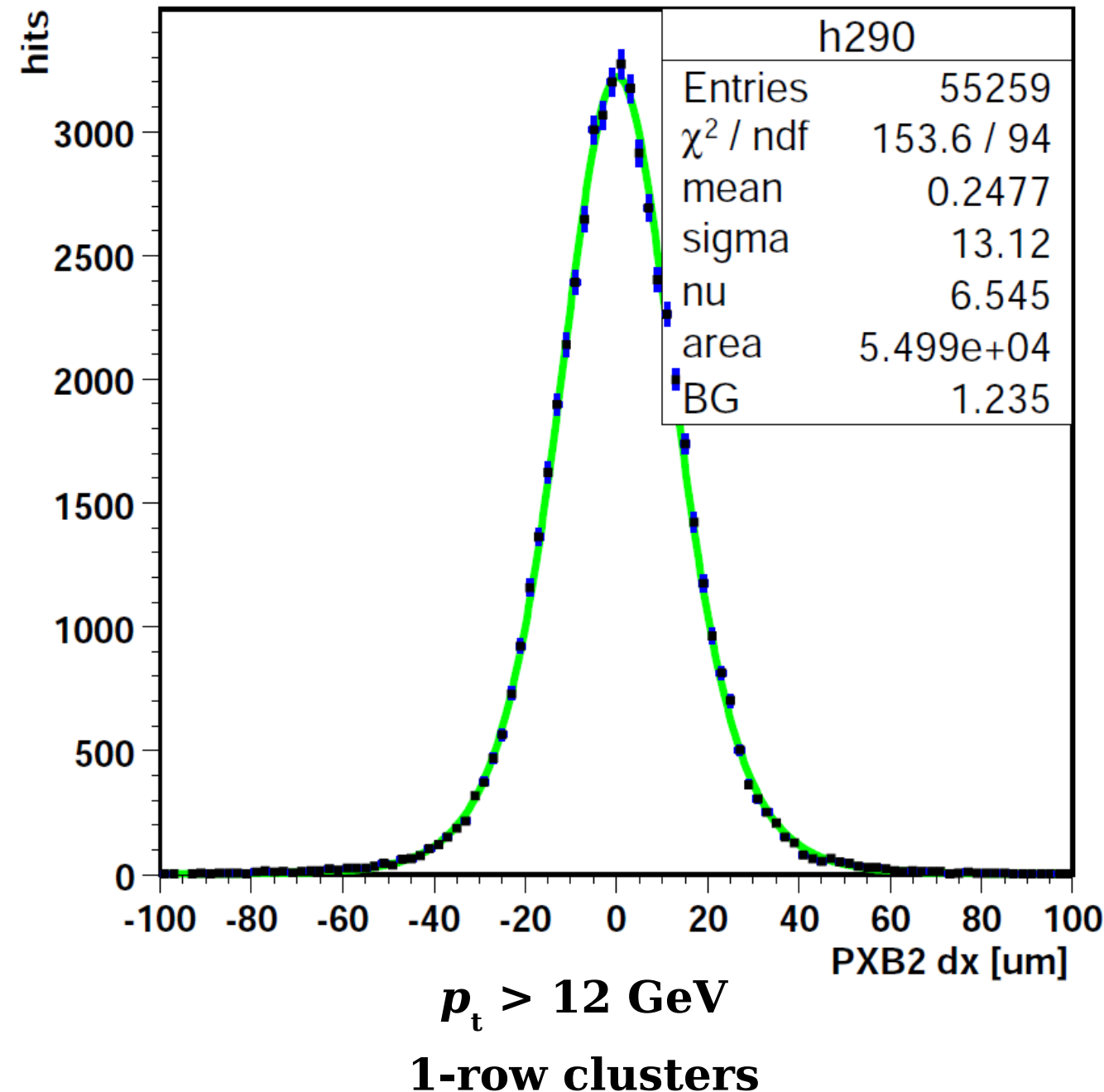


zoom into pixel



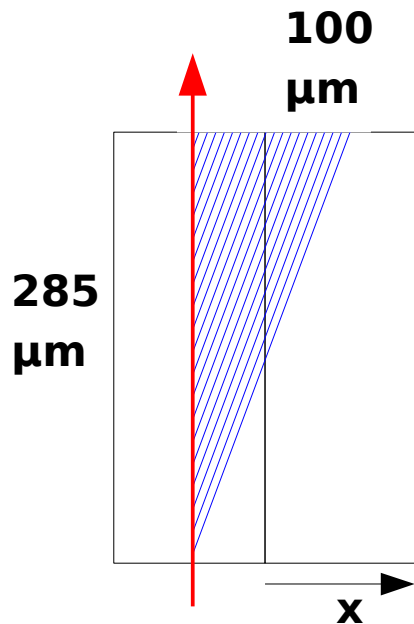
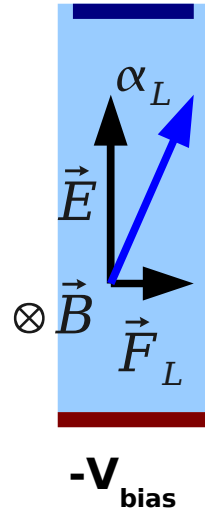
- $x_{\text{pix}} = \text{fmod}(x_{\text{loc}} + 0.8, 0.01)$.
- Predicted distribution is flat, as expected.
- Reconstructed position from Pixel-CPE-with-Templates:
 - peak at 97 from 1-row clusters,
 - peak at 46 μm ?
 - almost flat between 22 and 74 μm .

triplet x residuals for 1-row clusters



- Data Mar 2011
- Mean of the residual distribution is zero:
 - no bias, alignment OK.
- Width of the residual distribution at high p_t :
 - $\sigma_r = 13 \mu\text{m}$.
 - OK.
- Upgrade:
 - ROC with lower thresholds
 - less 1-row clusters.

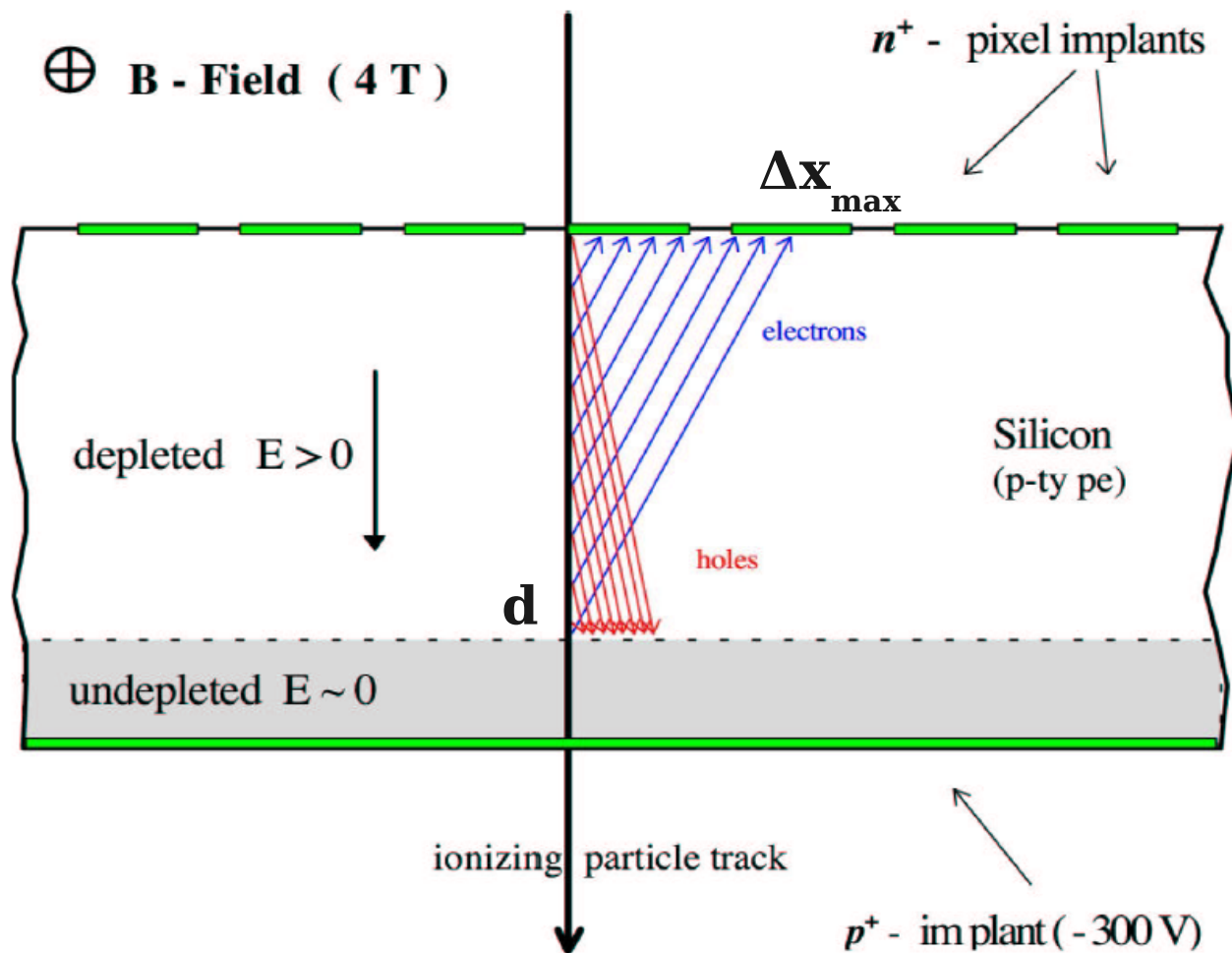
Lorentz angle



$$\text{atan}(100/285) = 19.3^\circ$$

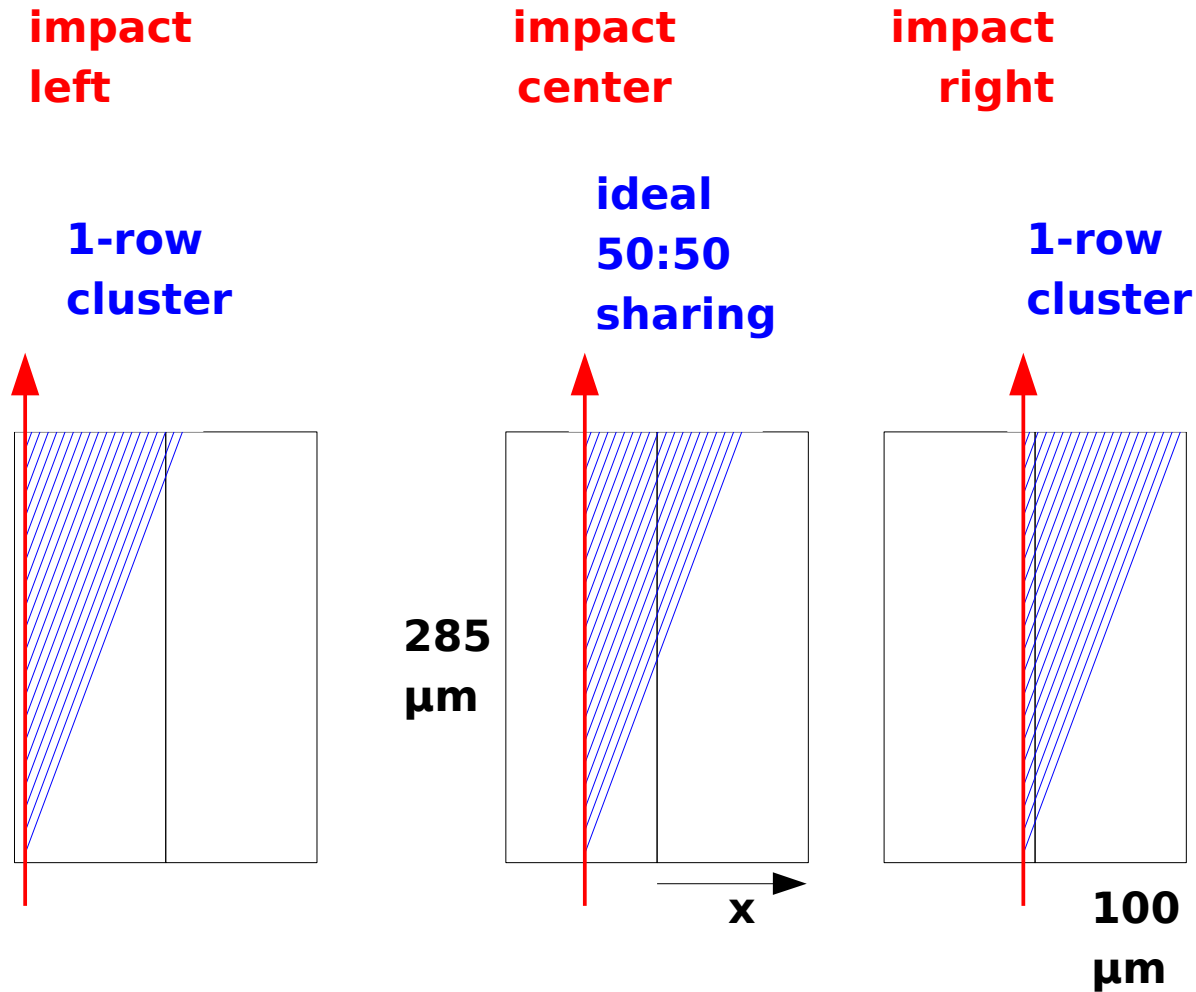
- Drift field:
 - $F = q E$
- Lorentz force:
 - $F_L = q v B$
- Drift velocity:
 - $v = \mu E$, Hall mobility μ
- Residual drift direction:
 - $\tan \alpha_L = F_L / F = \mu B$
- electrons in Si at 3.8 T, 0°C:
 - $\alpha_L \approx 20^\circ$
 - degrades with radiation

Lorentz drift



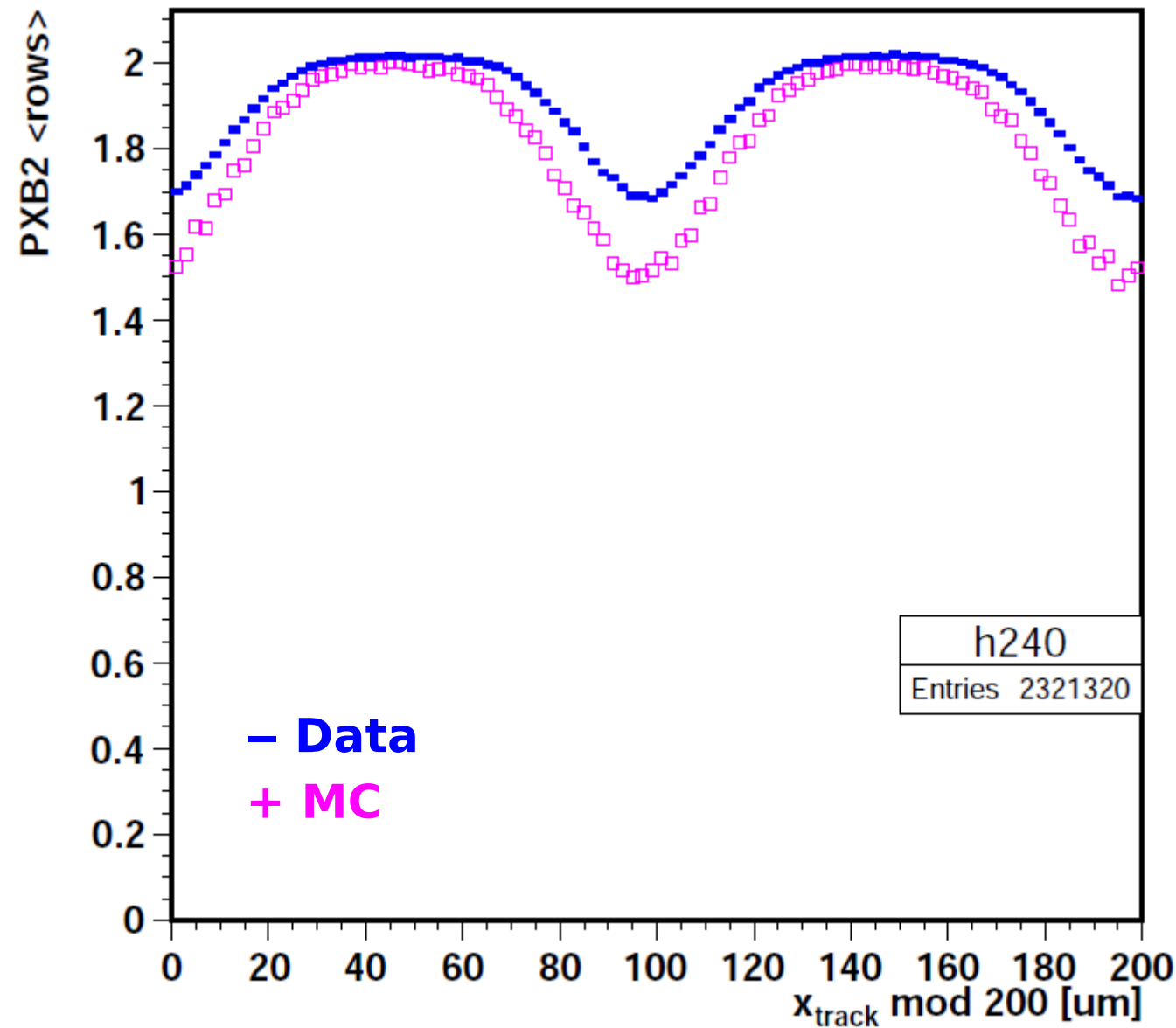
- $\tan \alpha_L = \mu B$
- electrons in Si at 3.8 T:
 - $\tan \alpha_L \approx 0.4$
- pixel sensors:
 - $d = 285 \mu\text{m}$
 - $\Delta x_{\max} = d \tan \alpha_L = 114 \mu\text{m}$
 - $\Delta x_{\text{mid}} = 0.5 d \tan \alpha_L = 57 \mu\text{m}$

Cluster size vs impact point



- $\tan \alpha_L = \mu B$
- electrons in Si at 3.8 T:
 - $\tan \alpha_L = 0.4$
- pixel sensors:
 - $d = 285\ \mu\text{m}$
 - $\Delta x_{\text{max}} = d \tan \alpha_L = 114\ \mu\text{m}$
 - $\Delta x_{\text{mid}} = 0.5 d \tan \alpha_L = 57\ \mu\text{m}$

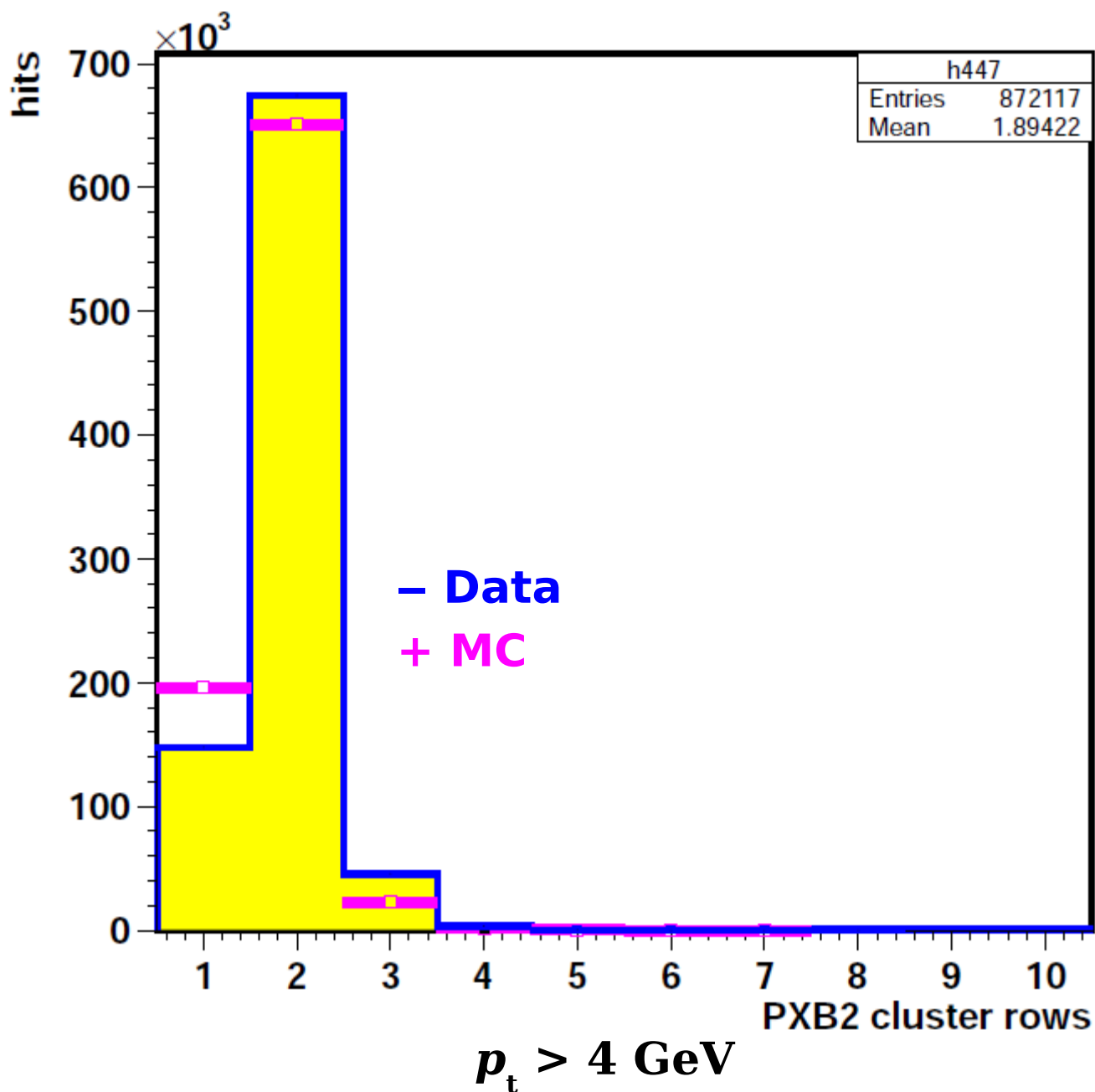
cluster size vs x impact point



$p_t > 4$ GeV

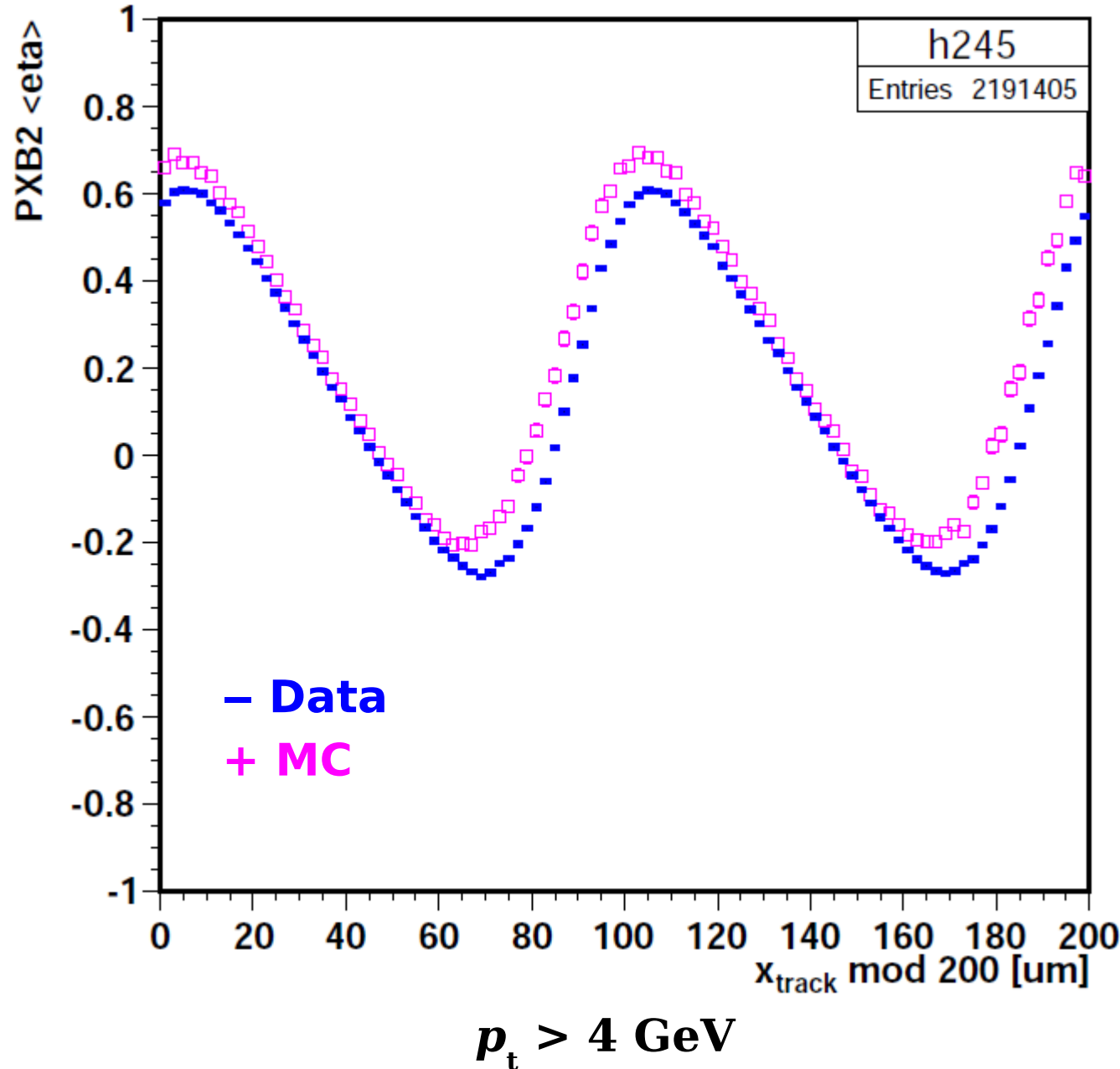
- mean number of rows per cluster vs predicted x position mod 200 μm .
- mostly 2-pixel clusters
 - ideal Lorentz angle
- 1-row clusters contribute near pixel boundaries, as expected from geometry.
- Simulation seems to have more 1-row clusters.

cluster size distribution



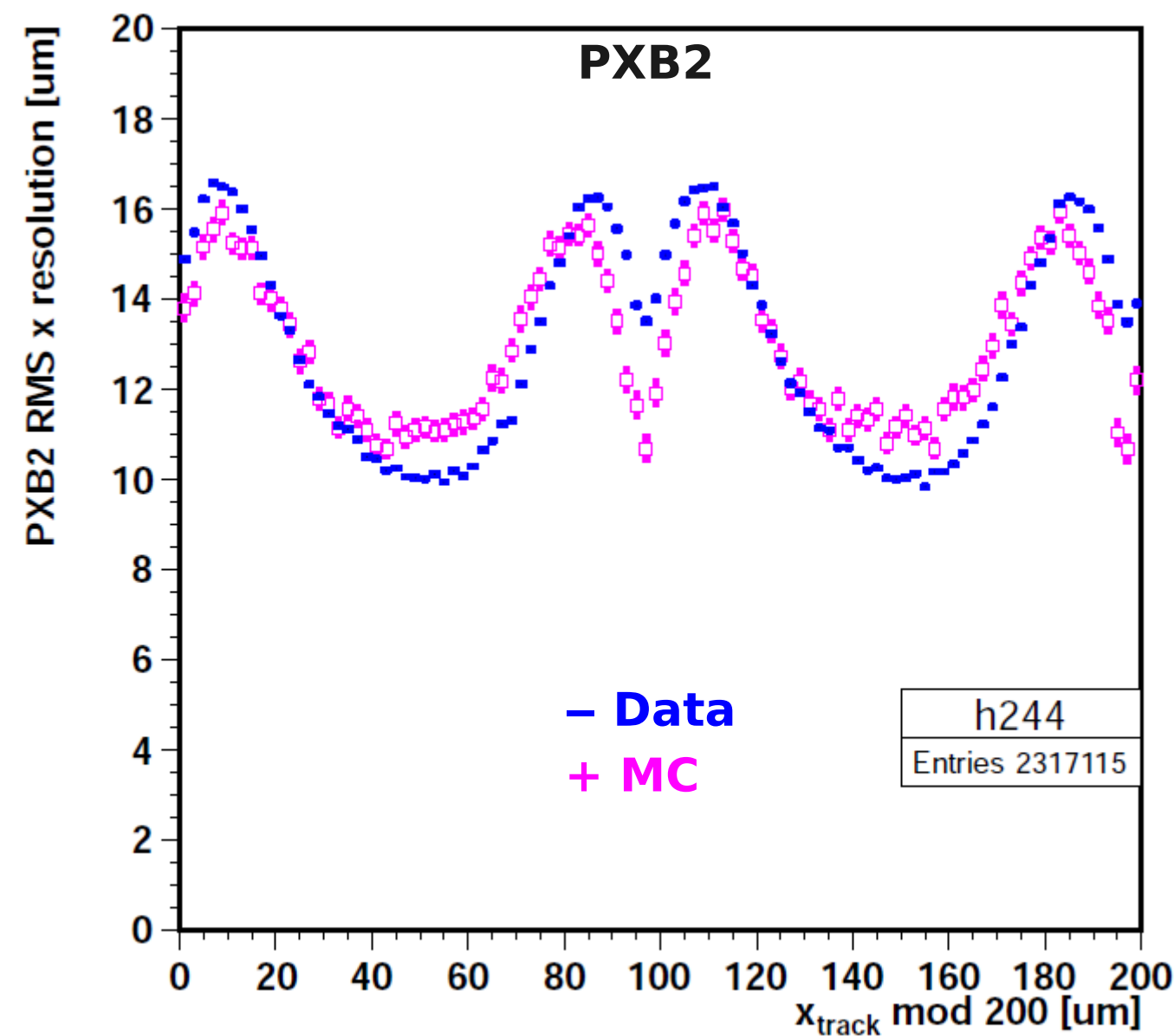
- mean number of rows per cluster.
- Simulation has 6% more 1-row clusters, less 2- and 3-row clusters:
 - too few δ rays?
 - too few merged clusters?

charge sharing vs x impact point



- 1- and 2-row clusters:
 - $\eta = (Q_L - Q_R) / Q_{\text{tot}}$
- saw-tooth would be ideal,
 - smearing due to track resolution, thresholds, gain non-linearity...
- Simulation has similar shape, slightly shifted.

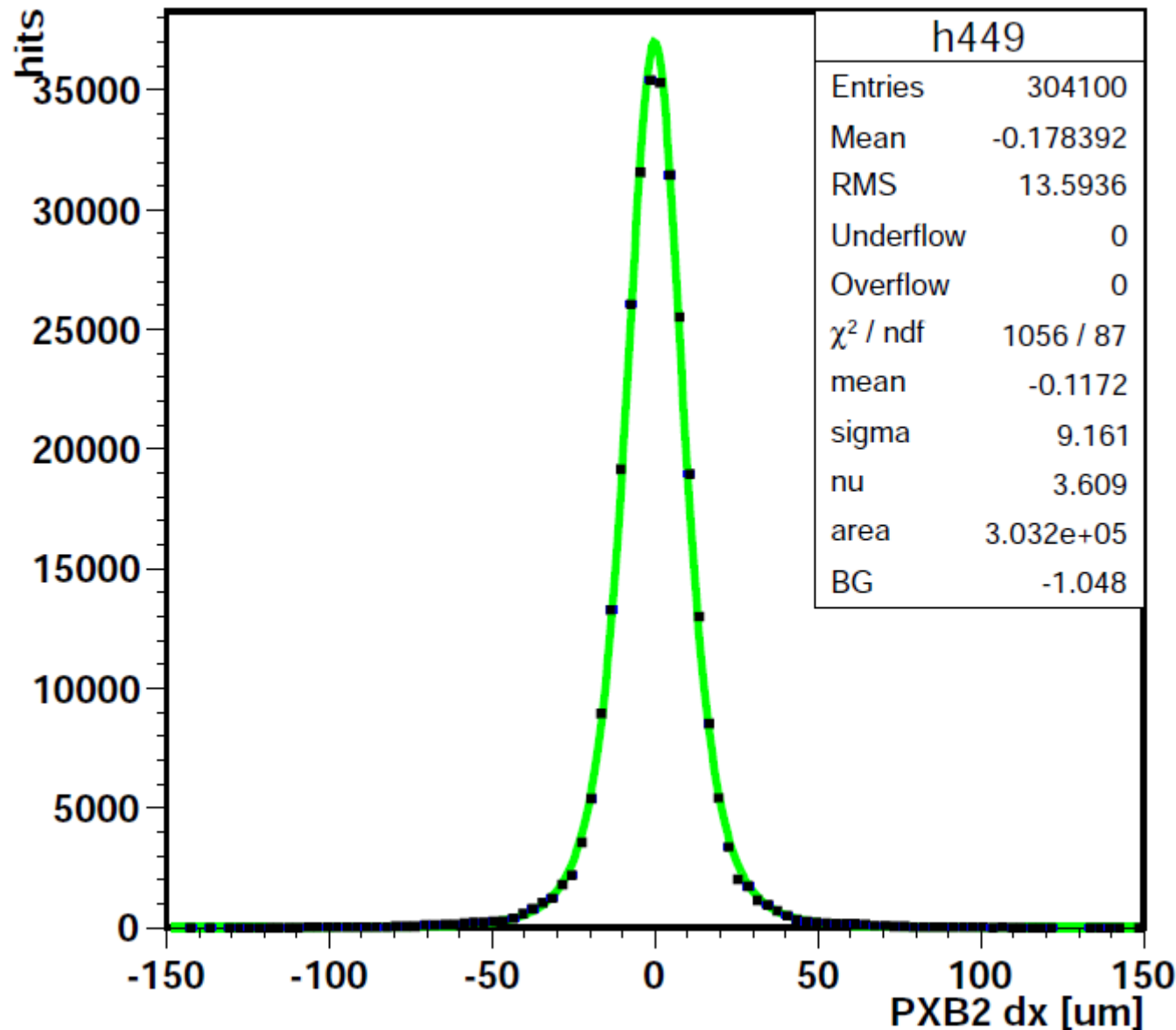
local x resolution in pixel



$p_t > 4 \text{ GeV}$

- Pixel rms x resolution from triplets vs predicted x in pixel mod 200 μm .
- Strong resolution variation from 10 to 16 μm :
 - best resolution at pixel center,
 - worst resolution near pixel edges.
- Simulation is similar, a little more pronounced.

triplet x residuals at pixel mid



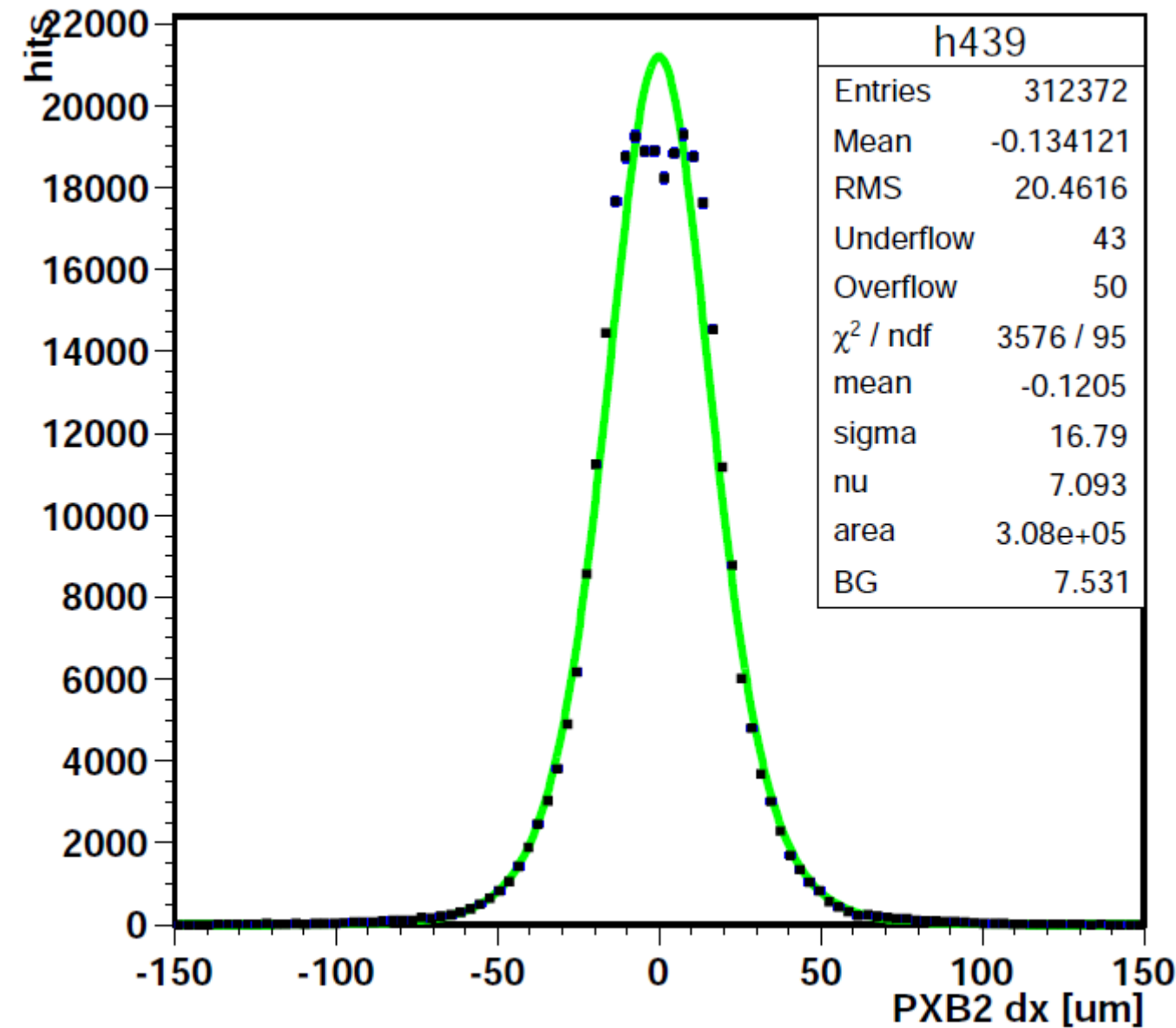
$p_t > 12 \text{ GeV},$

2-row clusters, $30 < x_{\text{track}} < 70 \text{ } \mu\text{m}.$

- Data Mar 2011
- Width of the residual distribution at high p_t :
- $\sigma_r = 9.2 \text{ } \mu\text{m}.$

$$\sigma_r^2 = \sigma_2^2 + (\sigma_1/2)^2 + (\sigma_3/2)^2$$
- Other layers have average $\sigma_i = 10.5 \text{ } \mu\text{m}.$
- Result:
 - $\sigma_2 = 5.4 \text{ } \mu\text{m}$ at pixel mid.
 - Somewhat academic: need to know that hit was in the middle.

triplet x residuals at pixel edge



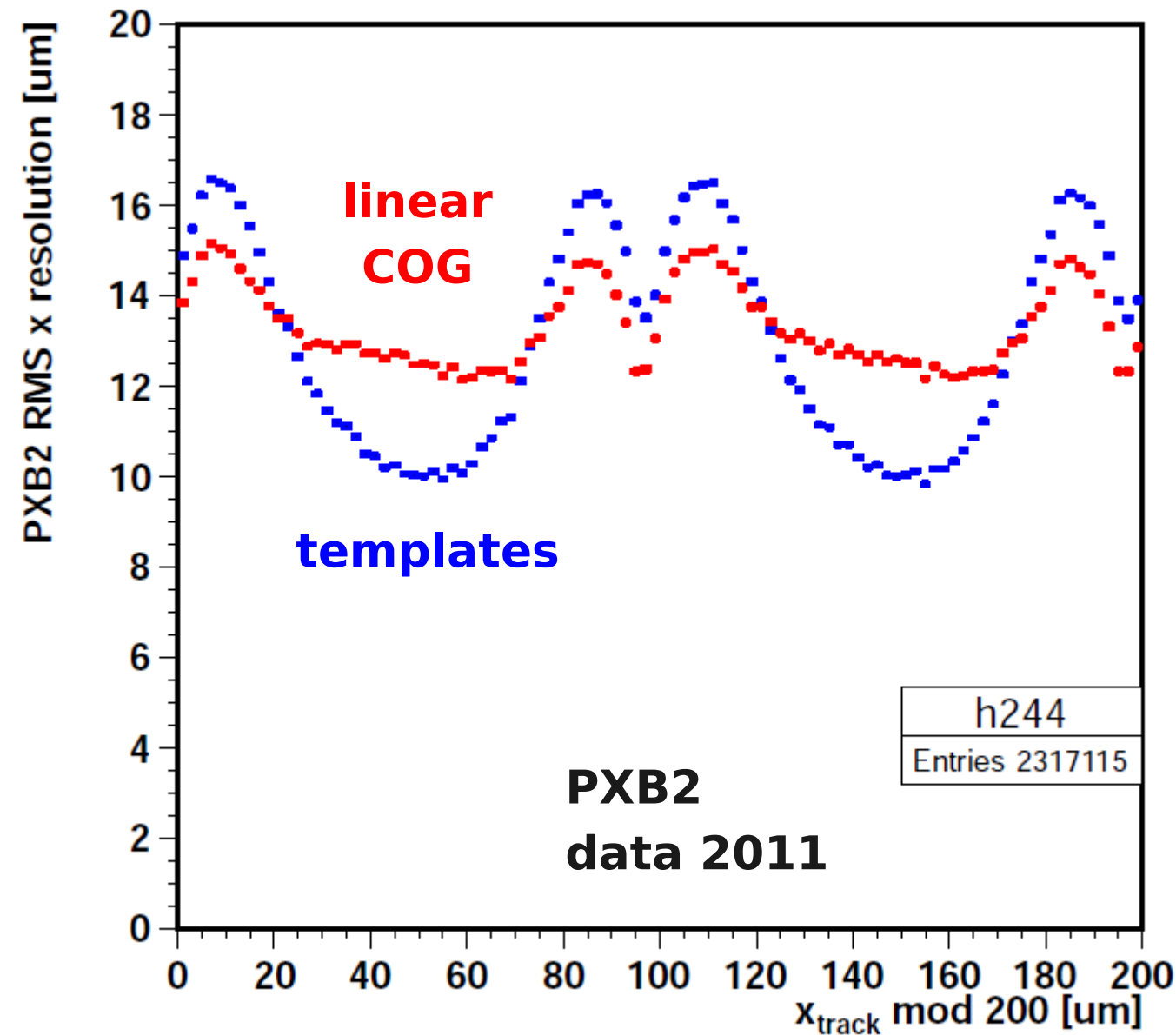
$p_t > 12 \text{ GeV}$

$x_{\text{track}} < 20 \text{ or } > 80 \text{ } \mu\text{m}.$

- Data Mar 2011
- Width of the residual distribution at high p_t :
- $\sigma_r = 16.8 \text{ } \mu\text{m}.$

$$\sigma_r^2 = \sigma_2^2 + (\sigma_1/2)^2 + (\sigma_3/2)^2$$
- Other layers have average $\sigma_i = 10.5 \text{ } \mu\text{m}.$
- Result:
 - $\sigma_2 = 15 \text{ } \mu\text{m}$ at pixel edge,
 - double peak?

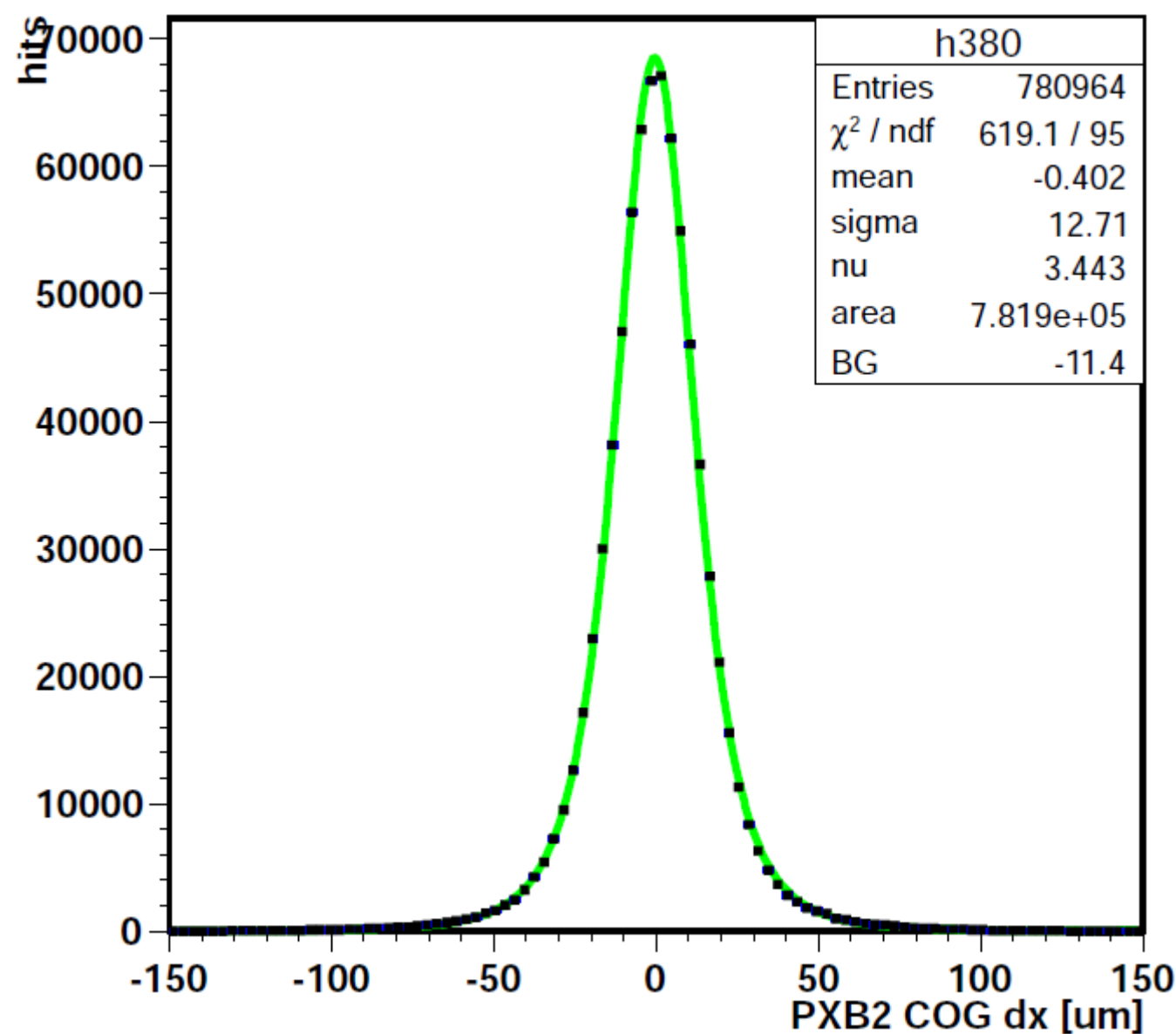
local x resolution in pixel



$p_t > 4$ GeV

- Pixel rms x resolution from triplets vs predicted x in pixel mod 200 μm .
- CMS standard templates varies from 10 to 16 μm .
- Simple cluster center-of-gravity algorithm:
 - worse resolution at pixel center,
 - better resolution near pixel edges.

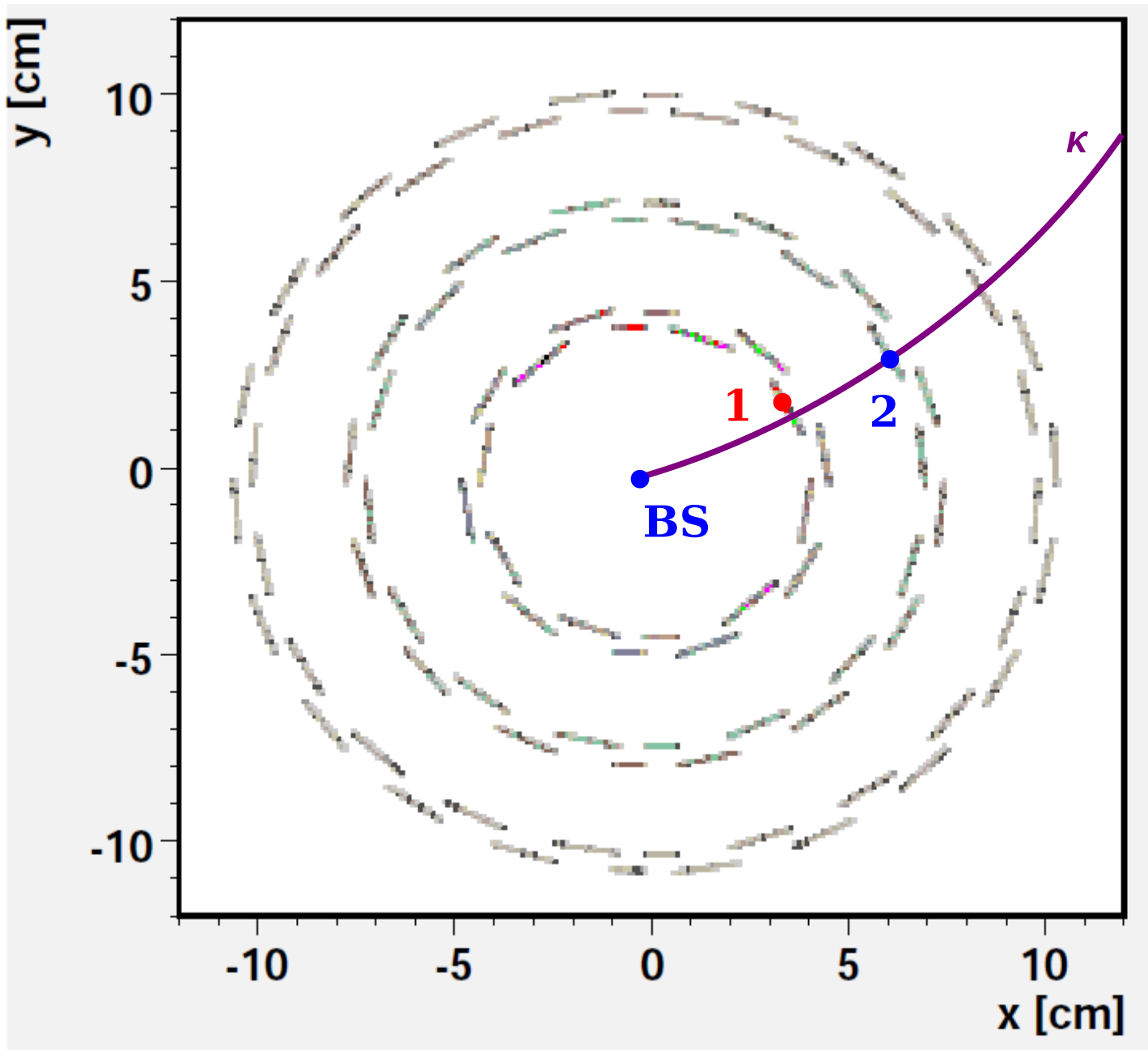
Pixel x resolution with the COG method



$p_t > 12 \text{ GeV}$

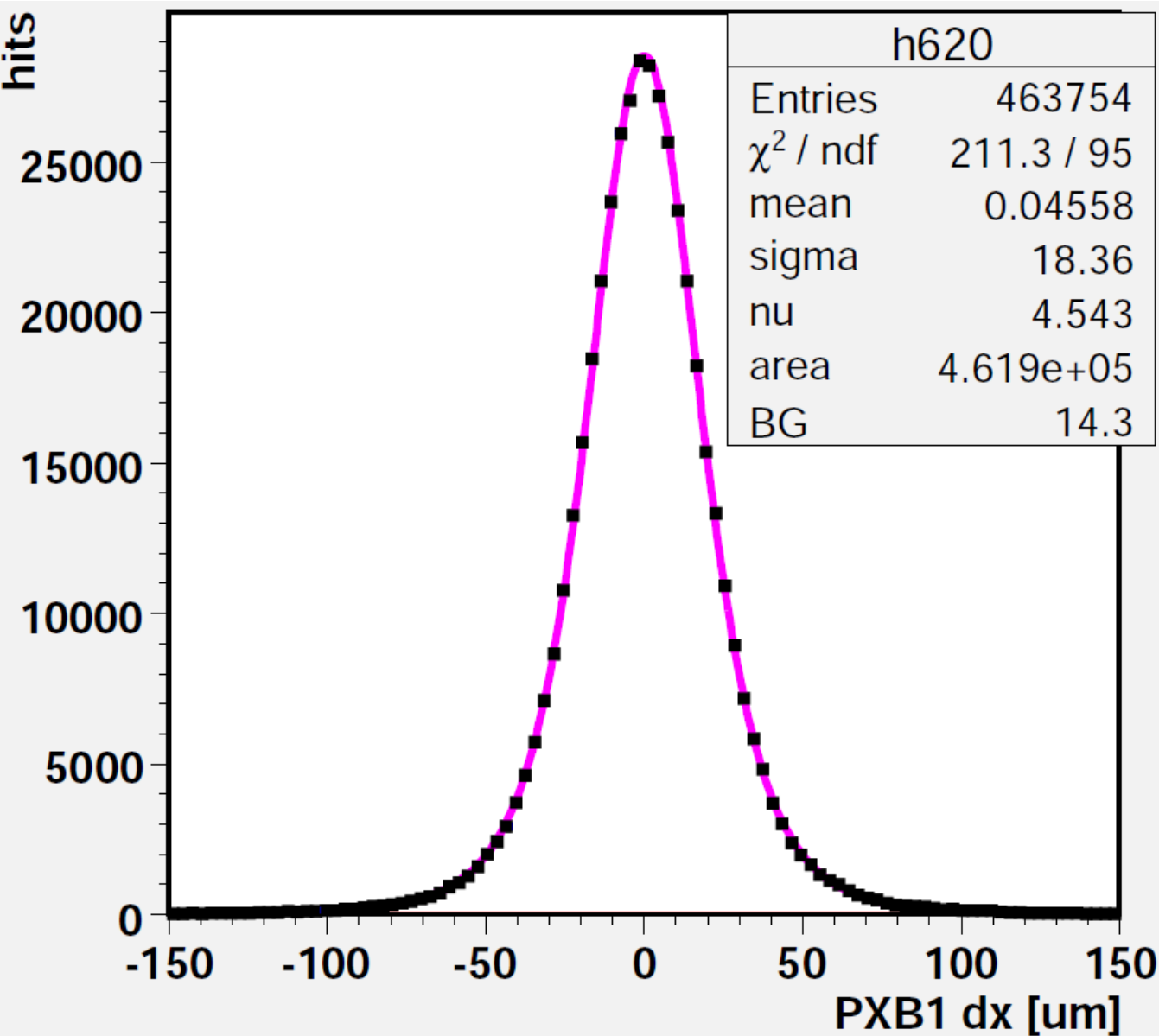
- Data Mar 2011
- Width of the residual distribution at high p_t :
- $\sigma_r = 12.7 \text{ } \mu\text{m}$.
$$\sigma_r^2 = \sigma_2^2 + (\sigma_1/2)^2 + (\sigma_3/2)^2$$
- Other layers have average $\sigma_i = 10.4 \text{ } \mu\text{m}$.
- Result:
 - $\sigma_2 = 10.4 \text{ } \mu\text{m}$ with COG method,
 - identical to CMS template method.

layer 1 residual using the beam spot



- Select tracks with hits in 2 pixel layers.
- Use offline beam spot.
- Impact parameter:
 $|d'_{CA}| < 5 \sigma$.
- Redefine track:
 - curvature κ from full tracker,
 - position and angle from beam spot and 2nd layer, in $r\phi$.
- Interpolate to 1st layer.

Layer 1 triplet $r\phi$ residuals at high p_t



$p_t > 12 \text{ GeV}$

- Data Mar 2011
- Width of the residual distribution at high p_t :

$$\sigma_r^2 = \sigma_1^2 + (\sigma_{BS}/2)^2 + (\sigma_2/2)^2$$

- Measured:
 - $\sigma_r = 18.4 \mu\text{m}$
- Assume for beam spot:
 - $\sigma_{BS} = 27 \mu\text{m}$
- Gives for intrinsic
 - $\sigma_1 = 11 \mu\text{m}$

Summary

- Triplet method for pixel hit residuals:
 - ▶ x and z resolutions across a module well described by simulation
 - ▶ x resolution varies strongly across one pixel:
 - ▶ best resolution at pixel mid (optimal charge sharing under Lorentz drift),
 - ▶ worst resolution near pixel edges (especially for 2-row clusters). Improvement possible?
 - ▶ Resolution of $10.5\text{ }\mu\text{m}$ previously observed seems to be a mixture of $5\text{ }\mu\text{m}$ at best and $15\text{ }\mu\text{m}$ at worst.
 - ▶ quite well described by simulation.
- Upgrade:
 - ▶ new ROC with lower thresholds
 - ▶ less 1-row clusters?
 - ▶ wider plateau with optimal resolution?

CMS Pixel DPG

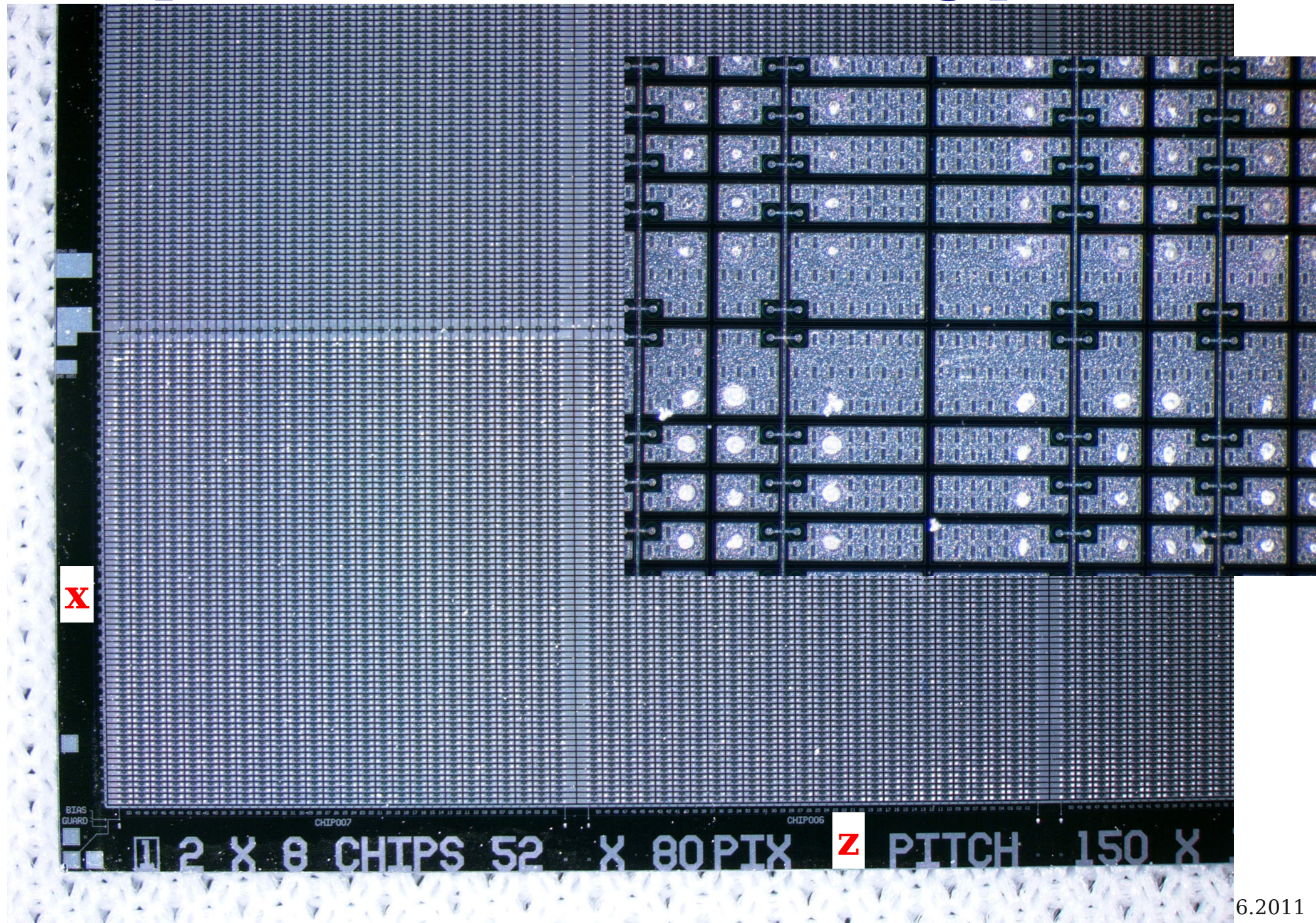
- Triplet method is established for pixel resolution studies.
 - Should be followed as function of time and radiation,
 - requires monitoring of cluster size, charge sharing, alignment, and beam spot position and size as well.
- Reporting to the Pixel Detector Performance Group:
 - meeting bi-weekly Thursdays at 14:00, convenors Urs Langenegger (PSI) and Viktor Vezpremi (Hungarian Acad. Sci.)
 - part of the Tracker DPG, convenors Petra Merkel (Purdue) and Andrea Venturi (Pisa)

<https://indico.cern.ch/categoryDisplay.py?categId=1358>

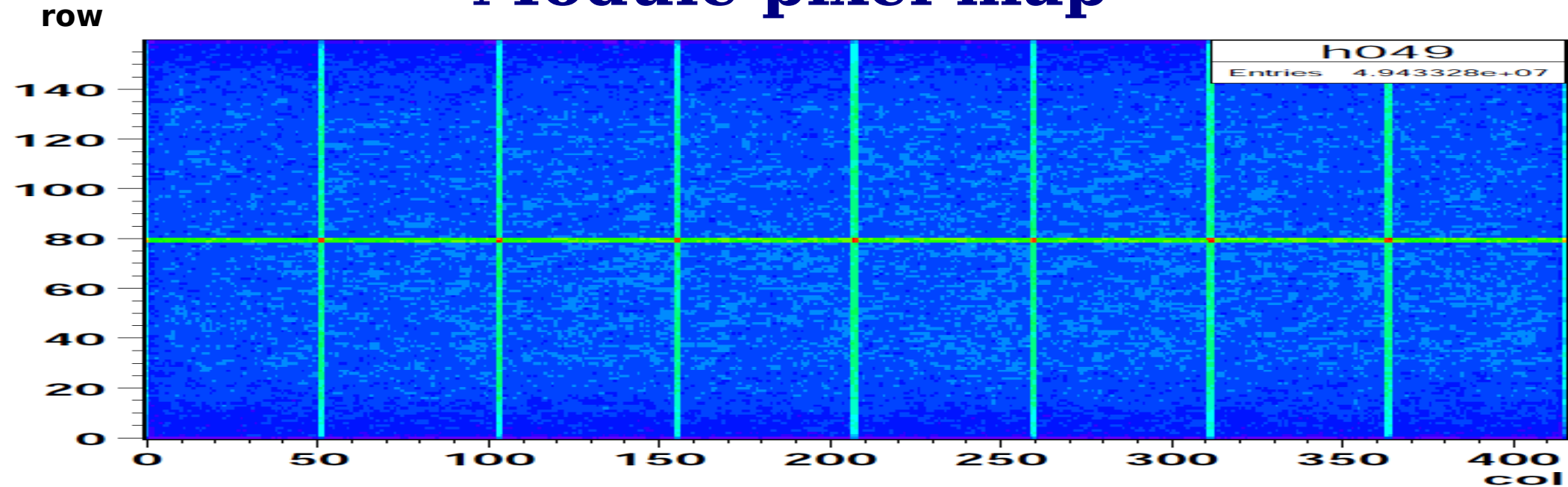
- Open tasks and credits:

<https://twiki.cern.ch/twiki/bin/viewauth/CMS/TrackerDPGManpowerNeeds2012>

pixel sensor: wide and long pixels

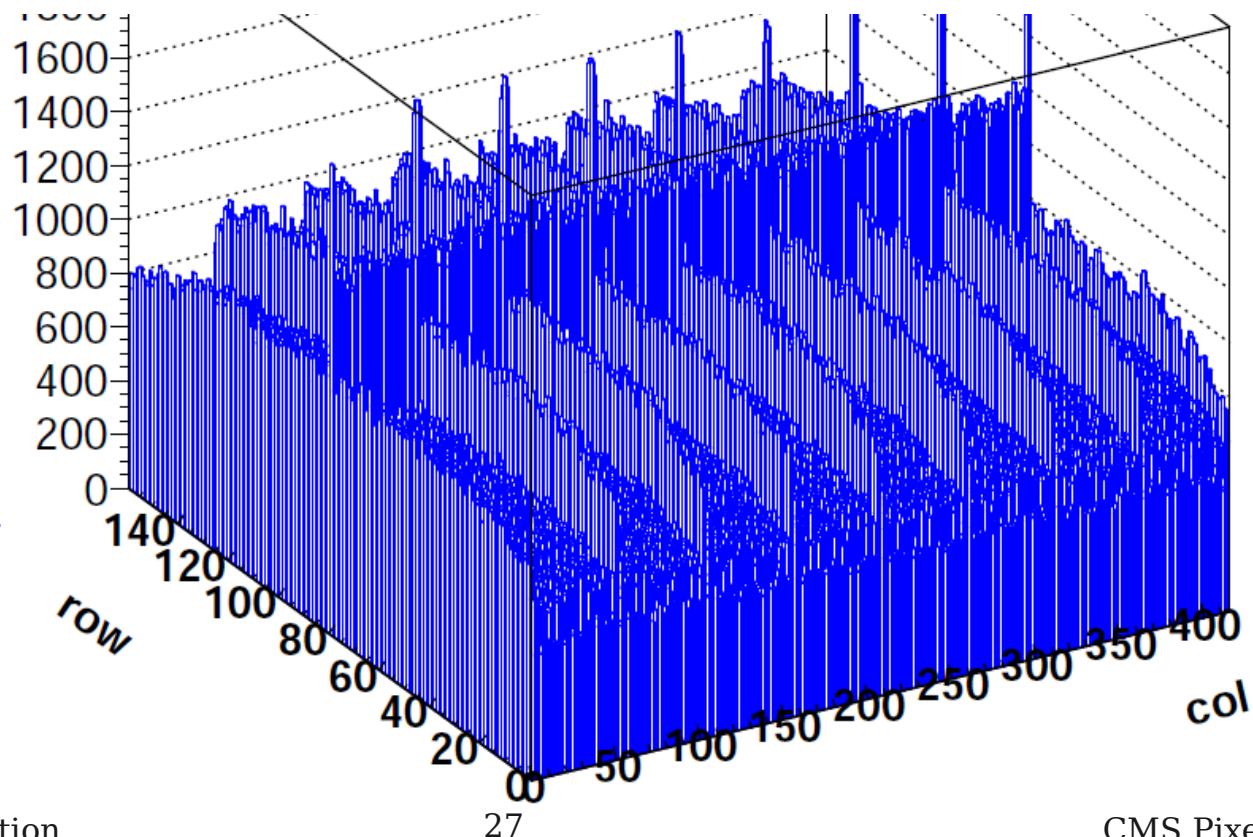


Module pixel map



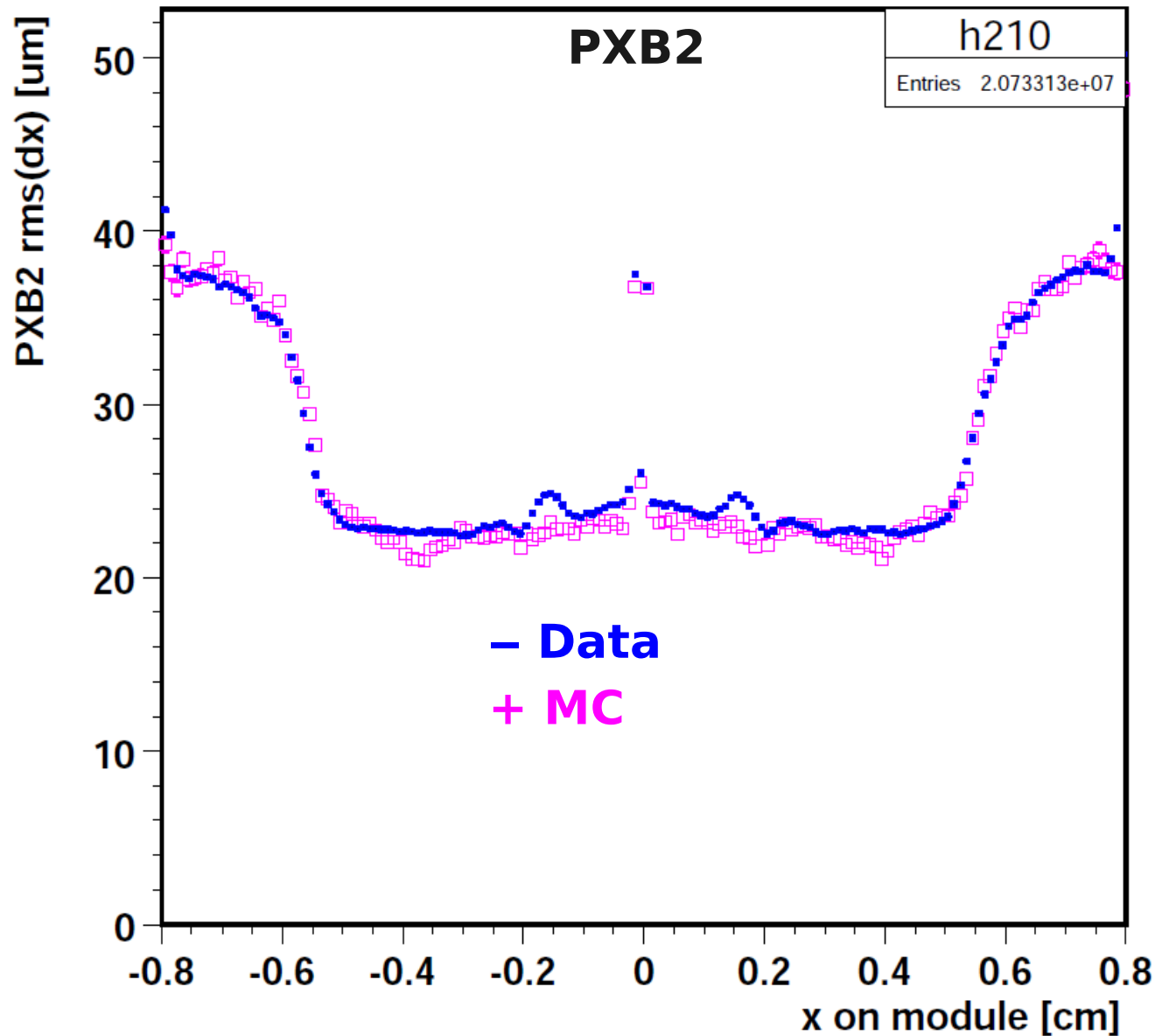
$x(\varphi)$
↑
z
→

rows 79 and 80:
wide pixels: 200
instead of 100 μm
to cover the ROC
edge.



columns
51, 52:
300 μm
instead
150 μm .

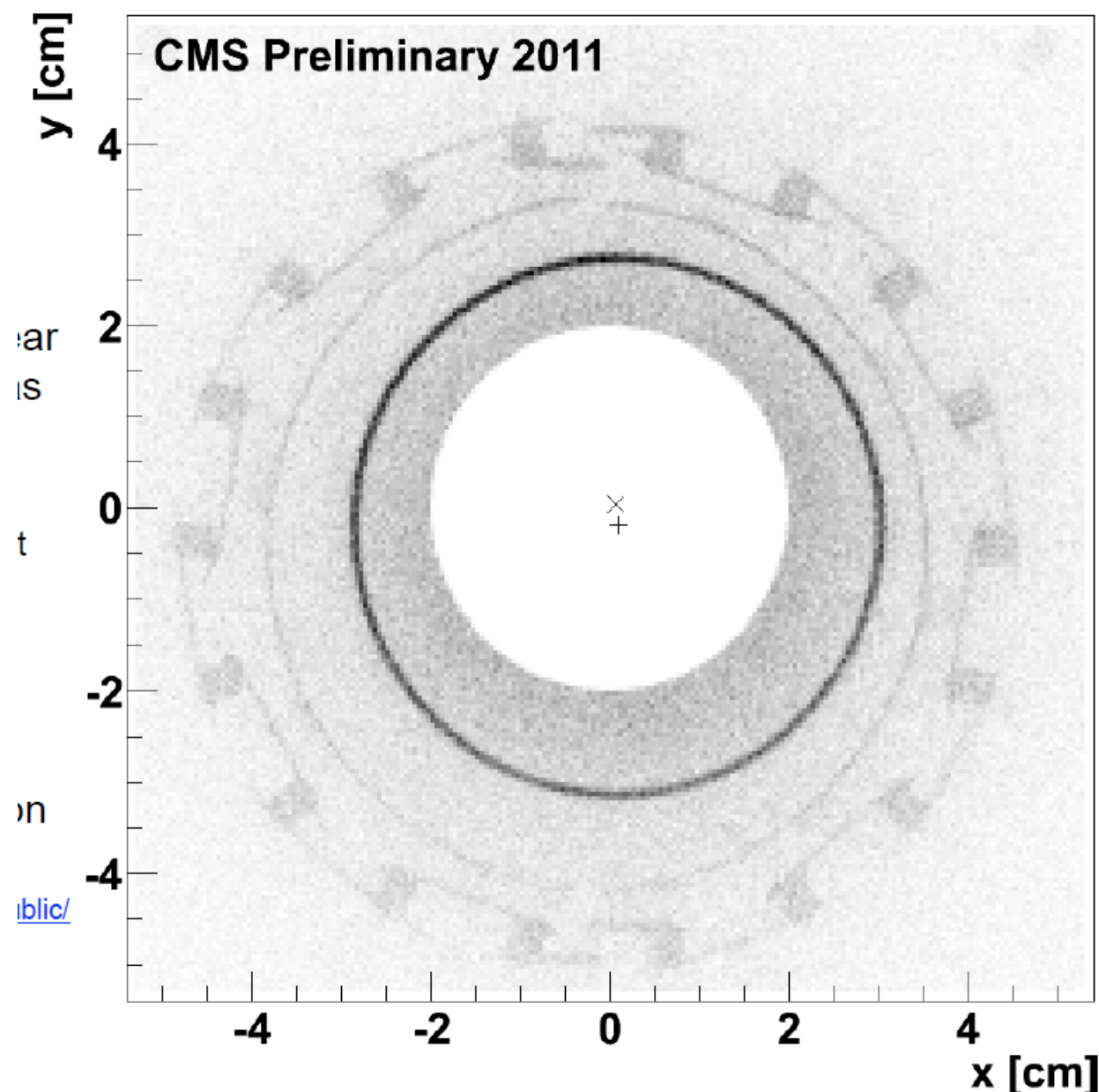
local x resolution at low p_t



$0.8 < p_t < 1.2 \text{ GeV}$

- Multiple scattering dominates at low p_t .
- Flat valley:
 - only silicon at mid-module.
- Peak at center:
 - wide pixels.
- Edges:
 - SiN base strips, cooling pipes.
- Well described by simulation. No phase shift when plotted in this way.

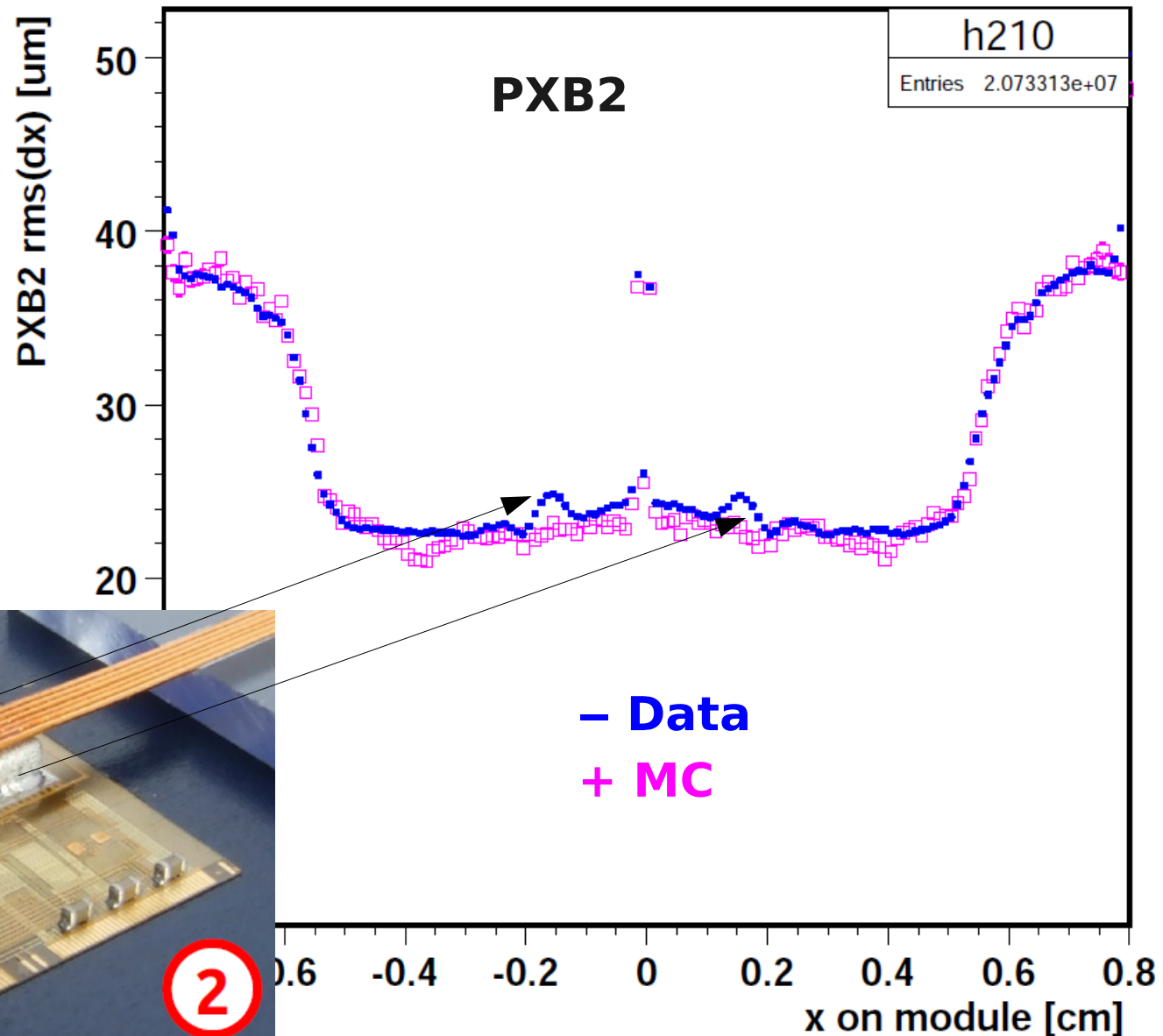
PXB1 in nuclear interactions



- Nuclear interaction vertices (M. Gouzevitch, G. Squazzoni).
- <https://indico.cern.ch/conferenceDisplay.py?confId=123717>
- First pixel barrel layer with 18 cooling pipes clearly visible.

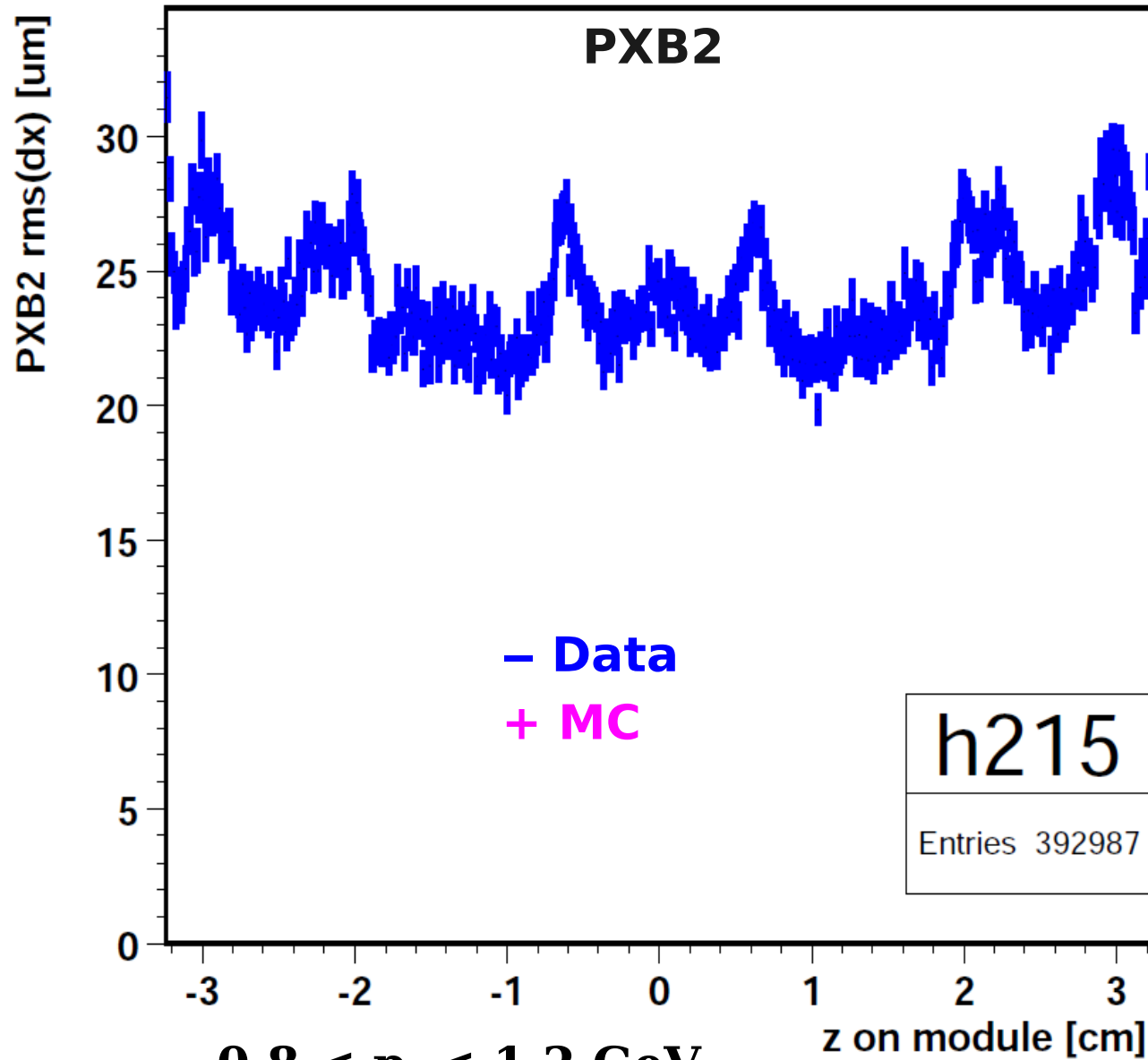
local x resolution at low p_t

resolution humps
at ± 0.15 cm
due to HV filter
capacitor?
Make z profile in
 x -slices!



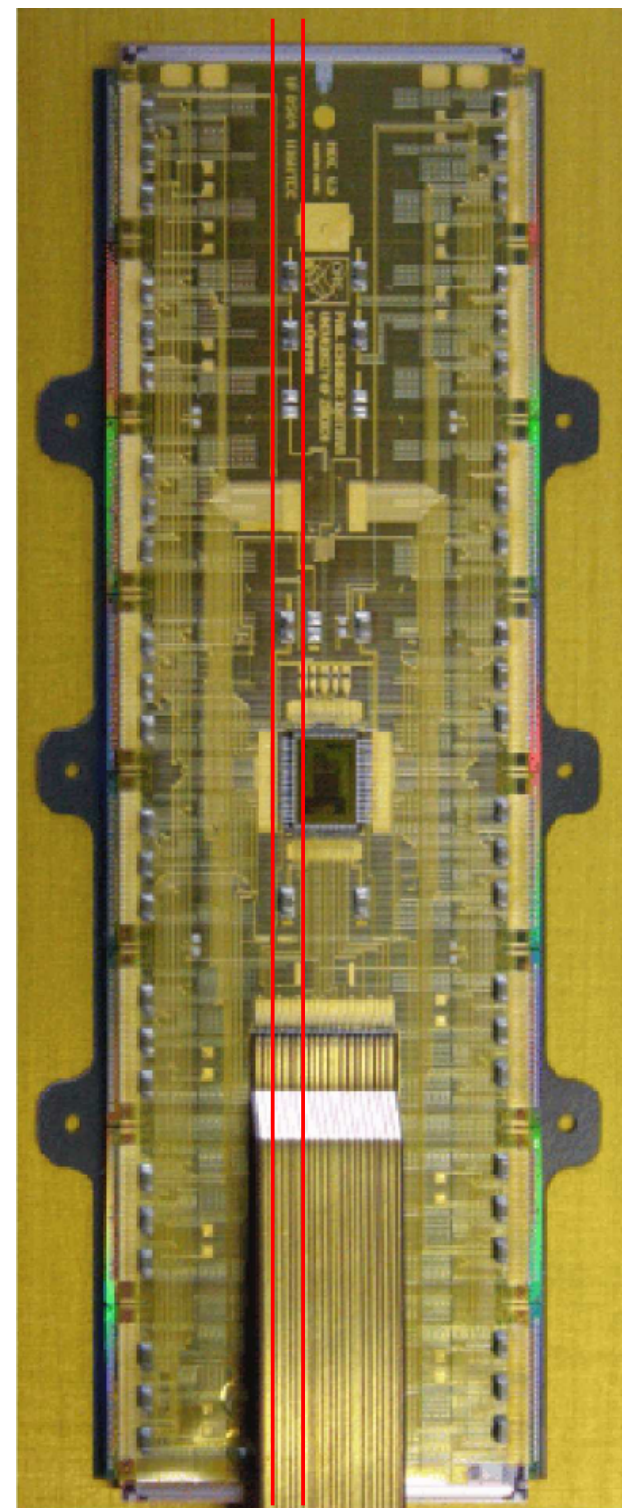
$0.8 < p_t < 1.2$ GeV

local x resolution at low p_t

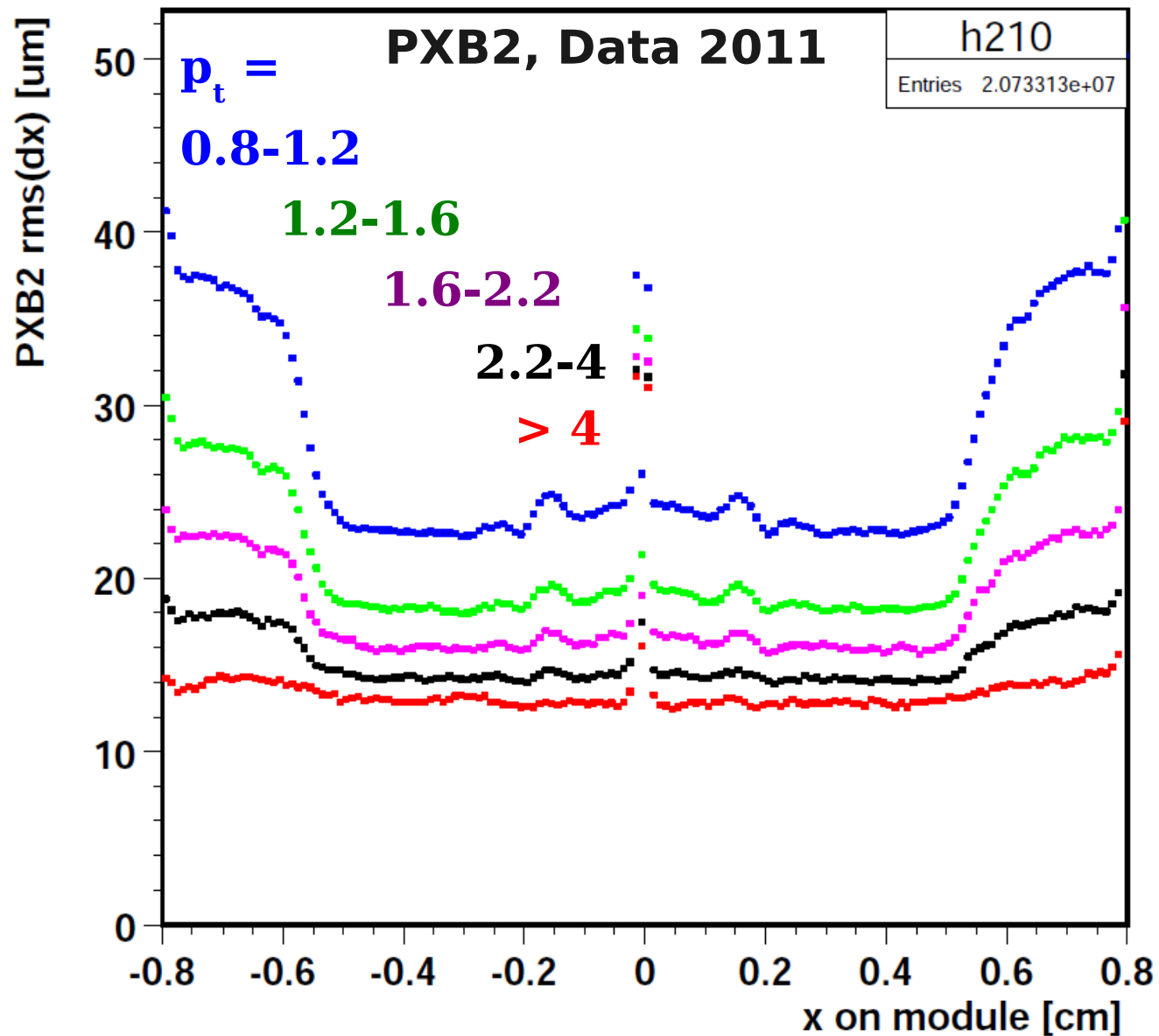


$0.8 < p_t < 1.2 \text{ GeV}$

$0.1 < |x_{\text{loc}}| < 0.2 \text{ cm}$

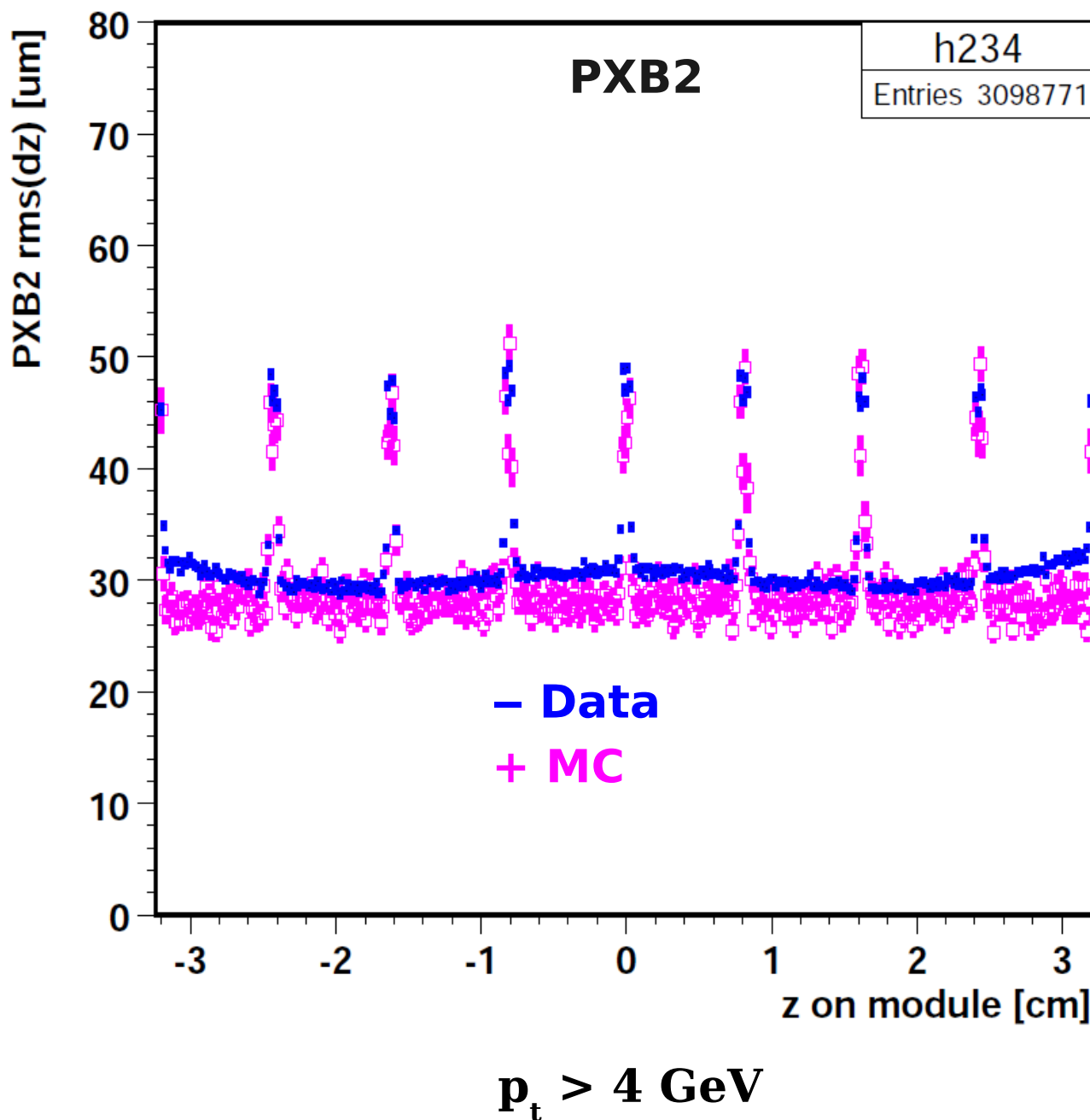


local x resolution vs p_t



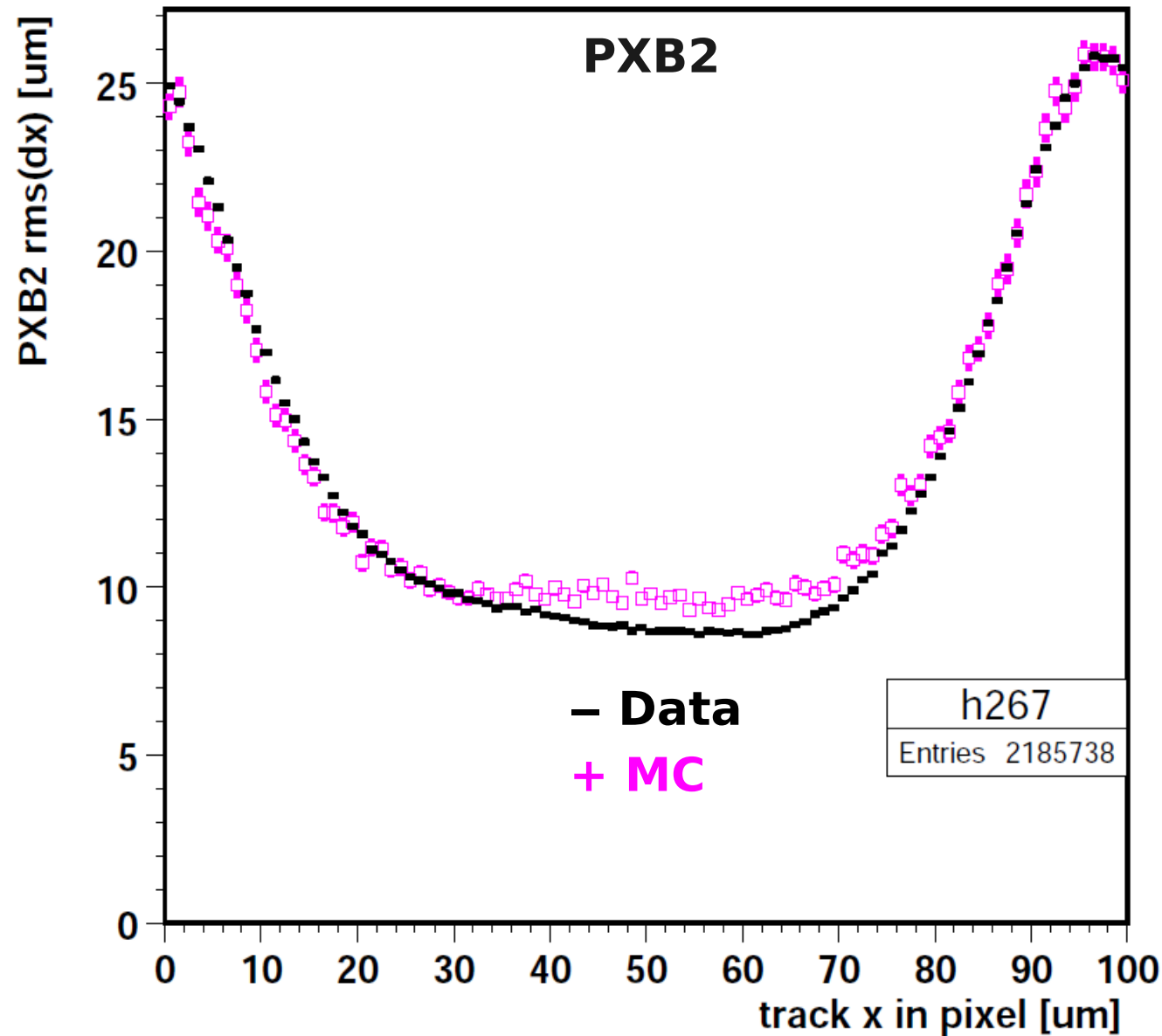
- Need $p_t > 4$ to reach intrinsic resolution.

local z resolution along module



- Triplet z residual rms.
- All angles, $p_t > 4$ GeV.
- Peaks every 0.8 cm:
 - long pixels at ROC edges.
- MC z resolution is slightly too optimistic.

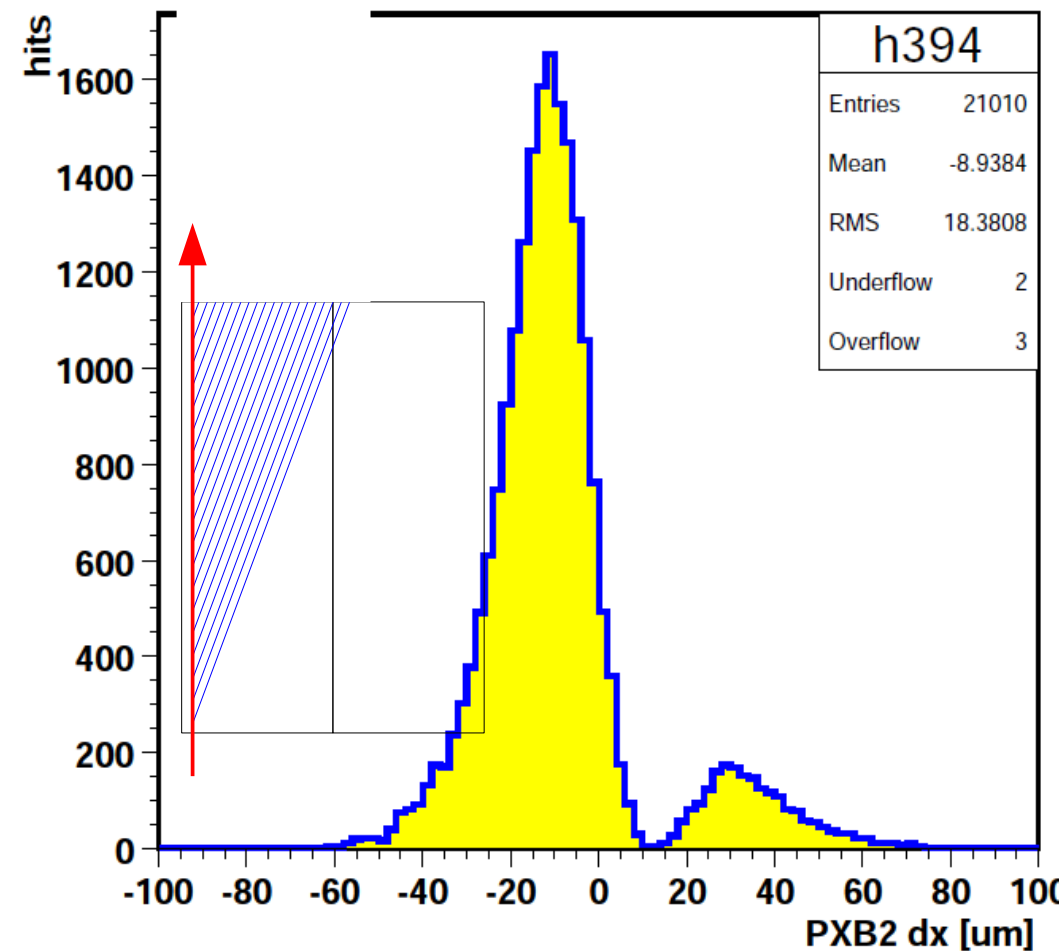
local x resolution in pixel



$p_t > 4$ GeV, 2-row clusters

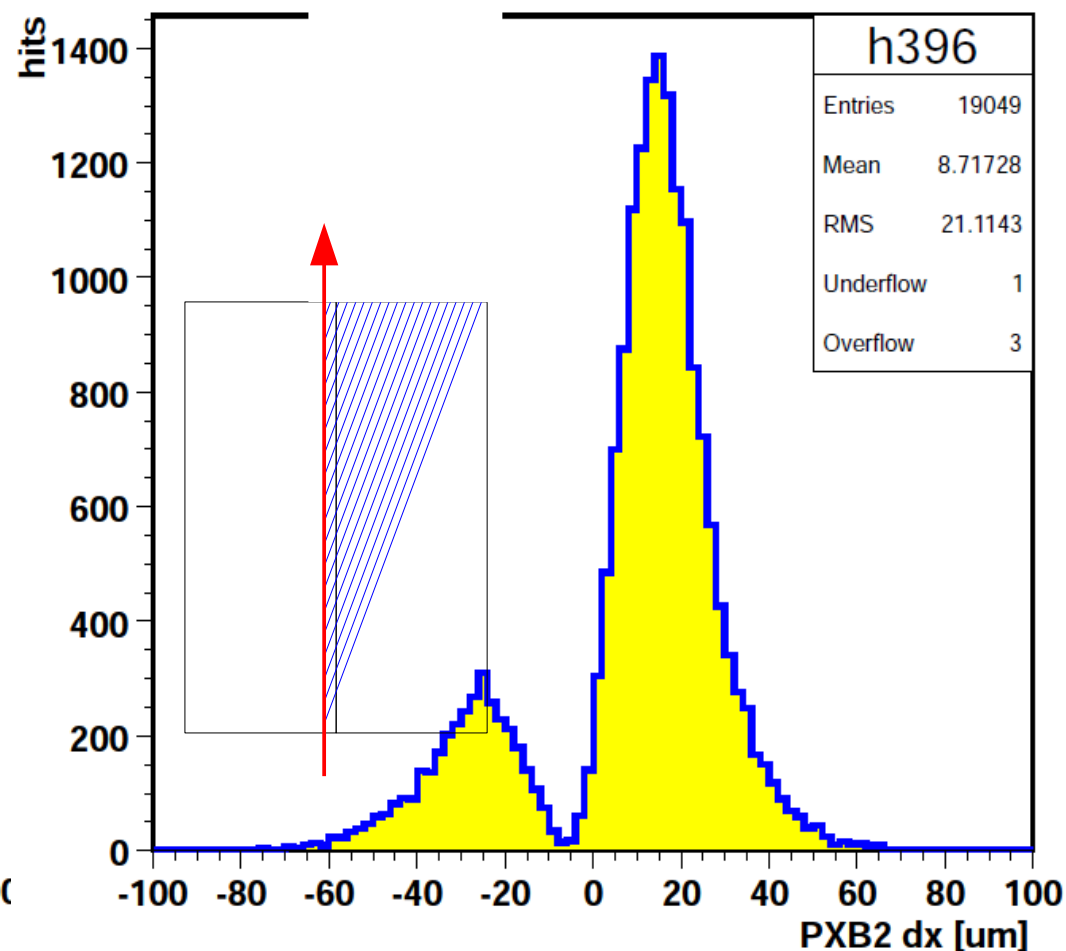
- Triplet x rms as function of predicted x in pixel at high p_t .
- Strong resolution variation from 9 to 25 μm :
 - best resolution at pixel center,
 - worst resolution near pixel edges.
- Well described by the simulation.

triplet x residuals at pixel edge



$p_t > 12$ GeV, 2-row cluster

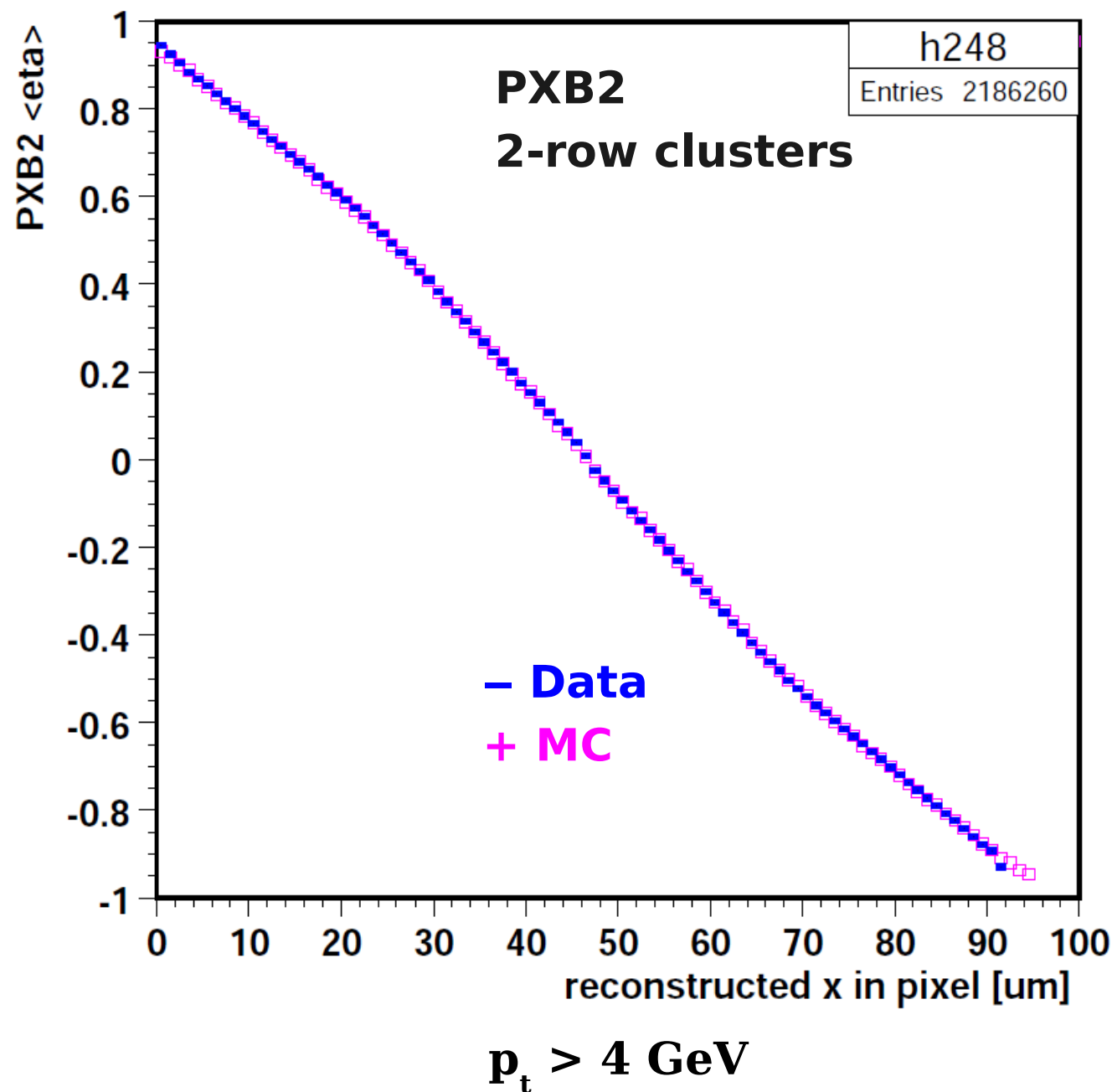
$x_{\text{pix}} < 20$ μm , outward module



$p_t > 12$ GeV, 2-row cluster

$x_{\text{pix}} > 80$ μm , outward module

charge sharing



- 2-row clusters:
 - $\eta = (Q_L - Q_R) / Q_{\text{tot}}$
- almost linear:
 - uniform charge sharing due to Lorentz drift.
- $x > 90 \mu\text{m}$:
 - only 1-row clusters.
- Perfect description by MC:
 - algorithm tuned to MC.

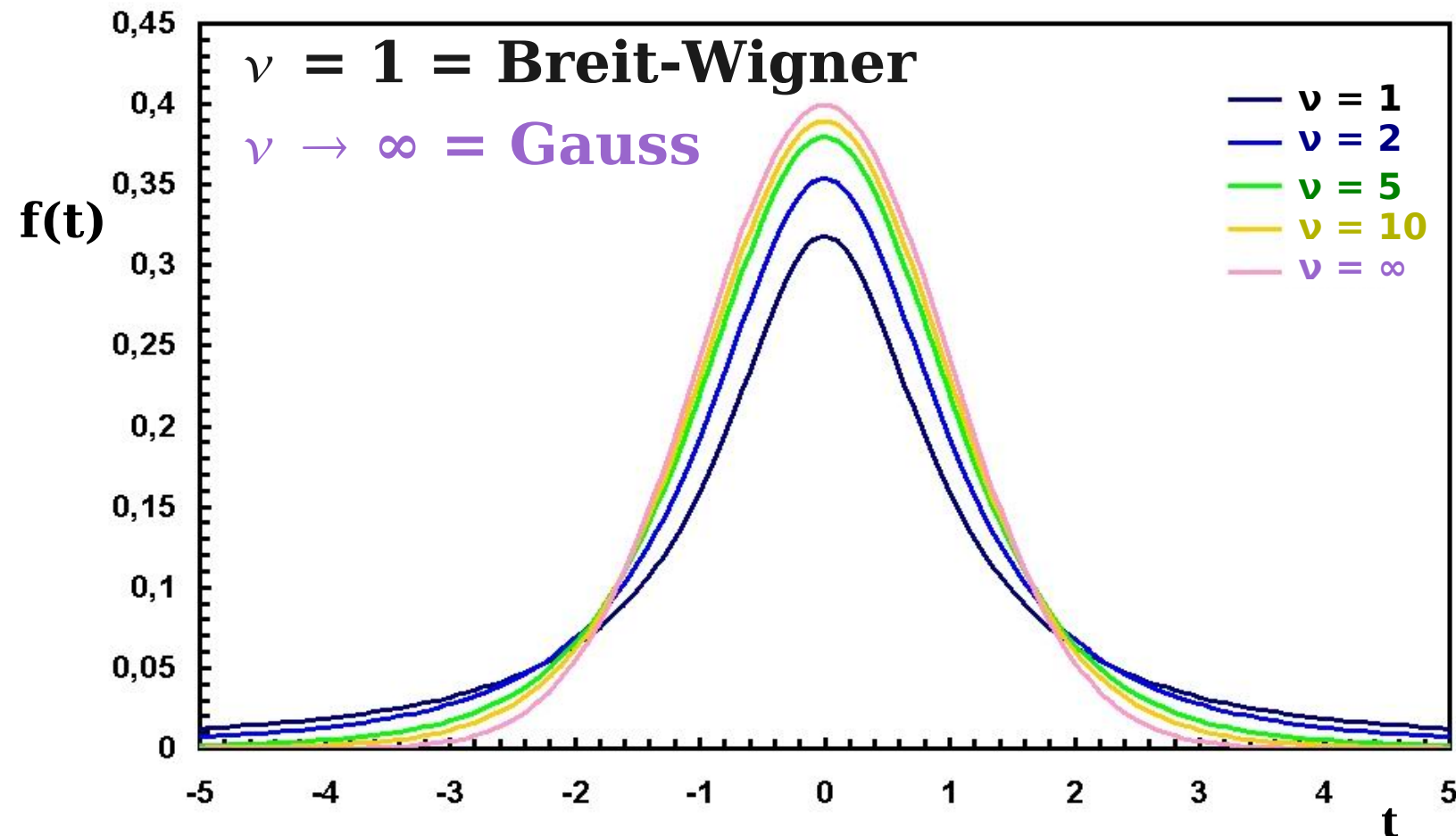
Fitting peaks with Student's t

$t = (x - x_0)/\sigma = \text{normalized residual.}$

$$f(t) = \frac{\Gamma((\nu + 1)/2)}{\sqrt{\nu\pi} \Gamma(\nu/2)} (1 + t^2/\nu)^{-(\nu+1)/2}$$

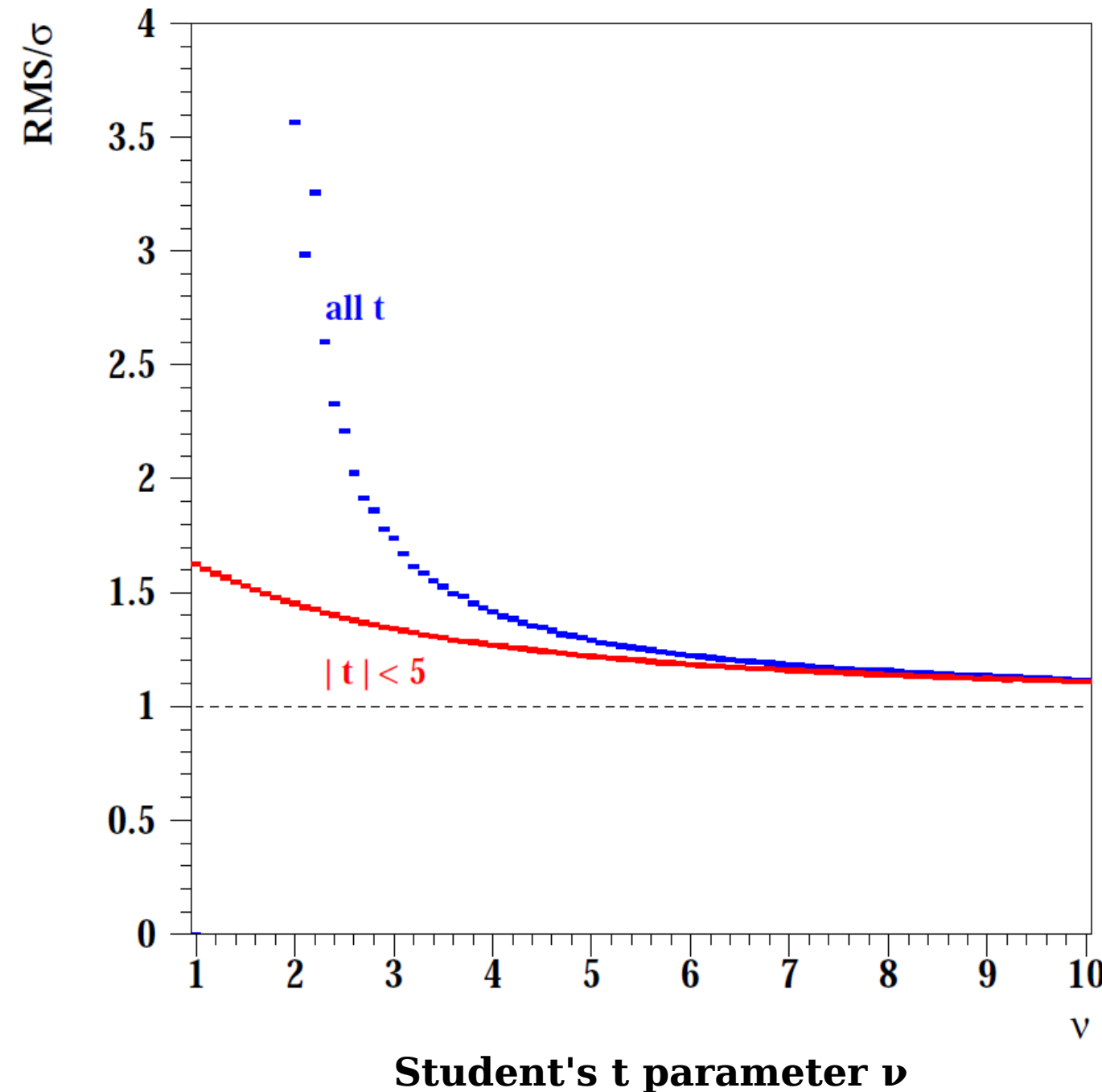
$f(t)$ is a normalized probability density.

Γ function is in PAW, ROOT.



Parameter ν interpolates between Gaussian and Breit-Wigner.

rms/ σ for Student's t



- Generate random numbers according to Student's t for different ν (see W. Hoermann, Computing 81 (2007) 317).
- calculate rms:
 - for all t. (rms diverges for $\nu = 1$).
 - for $|t| < 5$. (rms stays below 1.62 for all $\nu \geq 1$).
- Asymptotic value ($\text{rms}/\sigma = 1$) slowly approached.